

FCC TAS validation – Part 2: Tests under dynamic transmit power scenarios

FCC ID : A4RG4HCD
Equipment : Phone
Model Name : G4HCD
Applicant : Google LLC
1600 Amphitheatre Parkway,
Mountain View, CA, 94043 USA
Standard : FCC 47 CFR Part 2 (2.1093)

The product was received on Dec. 16, 2025 and testing was started from Mar. 14, 2026 and completed on Apr. 28, 2026. We, SPORTON INTERNATIONAL INC., would like to declare that the tested sample provide by manufacturer and the test data has been evaluated in accordance with the test procedures given in 47 CFR Part 2.1093 and FCC KDB and has been pass the FCC requirement.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL INC. Laboratory, the test report shall not be reproduced except in full.



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Table of Contents

1. Overview	4
2. Operating Parameters for Algorithm Validation.....	5
3. Overview of TA-SAR/TA-PD Test Proposal	7
4. TA-SAR Validation via Conducted Power Measurements	9
4.1 Measurement Setup.....	9
4.2 Test Sequences for all scenarios	12
4.3 Power Limit Table and Test Configurations	15
4.4 Measurement Results for Scenario1: Range of TA-SAR Parameters	21
4.5 Measurement Results for Scenario1: NTN Max Power	21
4.6 Conducted Power Measurement Results for Scenario 2: Time-Varying TX Power.....	22
4.7 Conducted Power Measurement Results for Scenario 3: Call Disconnection and Re-establishment.....	30
4.8 Conducted Power Measurement Results for Scenario5 Band Handover	30
4.9 Conducted Power Measurement Results for Scenario 5: ECI Change	31
4.10 Conducted Power Measurement Results for Scenario 7: Time Window Switching.....	32
4.11 Conducted Power Measurement Results for Scenario 8: SAR Exposure Switching	33
5. TA-SAR Validation via SAR Measurements	34
5.1 Measurement Setup.....	34
5.2 SAR Measurement Results for Scenario 2: Time-Varying TX Power	35
6. Conclusions.....	44
7. cDASY6 System Verification.....	45
7.1 The system to be used for the near field power density measurement	45
7.2 Test Side Location.....	45
7.3 SAR E-Field Probe.....	46
7.4 Data Acquisition Electronics (DAE).....	46
8. Test Equipment List	47
9. System verification and validation	48
9.1 Tissue Verification	48
9.2 System Verification	48
10. Uncertainty Assessment.....	49

Appendix A. Plots of System Performance Check

Appendix B. DASY Calibration Certificate

Appendix C. Test Setup Photos



History of this test report

Report No.	Version	Description	Issued Date
FA5N0805-01C	01	Initial issue of report	Apr. 29, 2026



1. Overview

The device support Mediatek developed TA-SAR/TA-PD Gen2 algorithm.

FCC regulation allows time-averaged RF power to demonstrate compliance with RF exposure safety limits. Because RF exposure is correlated to transmission power (TX power), e.g., lower RF exposure is correlated to lower TX power, the TX power can be controlled to meet FCC RF exposure limits defined specific absorption rate (SAR) limit for transmit frequencies < 6GHz and power density (PD) limit for transmit frequencies > 6GHz. For SAR limit, the proposed Time-Averaged Specific Absorption Rate (TA-SAR) algorithm manages TX power to always ensure that the time-averaged RF exposure is compliant with the FCC SAR requirement. For PD limit, the proposed Time-Averaged Power Density (TA-PD) algorithm controls TX power to ensure that the time-averaged RF exposure is compliant with the FCC PD requirement. In the FCC regulation and October 2018 TCB Workshop notes, the time averaging window of SAR is no more than 100 seconds for transmit frequencies less than 3GHz, no more than 60 seconds for transmit frequencies between 3GHz and 6GHz. The averaging window of PD is no more than 30 seconds for transmit frequencies between 6GHz and 10GHz, no more than 4 seconds for transmit frequencies between 24GHz and 42GHz, and no more than 2 seconds for transmit frequencies between 42GHz and 95GHz.

This document describes the test plan, test procedures, measurement setup, and measurement results for the verification of the proposed TA-SAR/TA-PD algorithm being able to make RF exposure meet the FCC requirement. The operating parameters for the algorithm validation are described in Chapter 2. The overview of the test proposal is given in TA-SAR/TA-PD algorithm document Chapter 3. The test procedures for the conducted power measurements and SAR measurements are described in TA-SAR/TA-PD algorithm document Chapter 4. The test procedures for the radiated power measurements and PD measurements are described in TA-SAR/TA-PD algorithm document Chapter 5. For the TA-SAR algorithm validation, the measurement setup for the conducted power tests and the corresponding measurement results are included in report section 4, while the nearfield SAR measurement setup and the test results are included in report section 5. For the TA-PD algorithm validation, the measurement setup for the radiated power tests and the corresponding measurement results are included in report section 6, while the near-field PD measurement setup and the test results are included in report section 7.

2. Operating Parameters for Algorithm Validation

The device support Mediatek developed TA-SAR/TA-PD algorithm to control instantaneous TX power for transmit frequencies less and larger than 6GHz respectively, so that the total time-averaged RF exposures (i.e., SAR, PD, and SAR+PD exposure) of WWAN are less than the FCC requirement.

The basic concept of WWAN algorithm is the same, if time-averaged TX power approaches a predefined TX power limit which is mapped from SAR or PD limit, the instantaneous TX power will be constrained to ensure that the time-averaged TX power is less than the predefined TX limit at all times. The following parameters listed in Table 2-1 is essential for TA-SAR algorithm operation.

Table 2-1 TA-SAR operating parameters for WWAN

Operating parameters	Description
$P_{\text{sub6_limit}}$	- Maximum time-averaged TX power limit (corresponding to SAR_design_limit, which is less than or equal to FCC limit in consideration of the sub6 device uncertainty, simultaneous transmission, etc.) for different bands of 2G, 3G, LTE, and NR FR1. - For a band, SAR_design_limit can be defined differently for a single-TX test case or a multi-TX test case (e.g., ENDC) due to the conservative consideration, and therefore Psub6_limit would be different correspondingly.
$P_{\text{UE_backoff_offset}}$	Parameter for calculating $P_{\text{UE_backoff}}$ $P_{\text{UE_backoff}} = \min (P_{\text{UE_max}}, P_{\text{sub6_limit}} - P_{\text{UE_backoff_offset}})$ $P_{\text{UE_max}}$ is maximum TX power at which a UE can possibly transmit.
$P_{\text{UE_max_cust_offset}}$	Parameter for calculating $P_{\text{UE_max_cust}}$ $P_{\text{UE_max_cust}} = \min (P_{\text{UE_max}}, P_{\text{sub6_limit}} + P_{\text{UE_max_cust_offset}})$

When the operating center frequency is above 6GHz, the following parameters, listed in Tables 2-2 is essential for the TA-PD algorithm operation.

Table 2-2 TA-PD operating parameters for WWAN

Operating parameters	Description
$P_{PD_Limit} [beam]$	The time-averaged maximum power level limit (corresponding to PD_design_limit, which is less than or equal to FCC limit in consideration of the device uncertainty, simultaneous transmission, etc.) for different bands/beams.
$P_{UE_backoff_offset} [beam]$	Parameter for calculating $P_{UE_backoff} [beam]$ $P_{UE_backoff} [beam] = \min (P_{UE_max}, P_{PD_Limit} [beam] - P_{UE_backoff_offset} [beam])$, where P_{UE_max} is maximum TX power at which a UE can possibly transmit.
$P_{UE_max_cust_offset} [beam]$	Parameter for calculating $P_{UE_max_cust}$ $P_{UE_max_cust} [beam] = \min (P_{UE_max}, P_{PD_Limit} [beam] + P_{UE_max_cust_offset} [beam])$

Table 2-3 Algorithm time-averaging window recommended in TCBC WS of October 2018

Interim Guidance	Frequency (GHz)	Maximum Averaging Time (sec)
SAR	< 3	100
	3 – 6	60
MPE	6 - 10	30
	10 - 16	14
	16 – 24	8
	24 – 42	4
	42 – 95	2

3. Overview of TA-SAR/TA-PD Test Proposal

For the completeness of verifying that the proposed TA-SAR algorithm can realize FCC compliance regarding RF exposure, several test scenarios are constructed as below:

- **Scenario 1:** test under different TA-SAR parameters to verify that the TA-SAR Gen2 algorithm meets compliance requirements with different combinations of operating parameters.
- **Scenario 2:** test under time-varying TX power to verify that the TA-SAR algorithm ensures SAR compliance through dynamic TX power.
- **Scenario 3:** test under call drop and re-establishment conditions to ensure that the TA-SAR algorithm can control continuity and maintain SAR compliance
- **Scenario 4:** test under RAT/band handover to ensure that the TA-SAR algorithm can control continuity and maintain SAR compliance
- **Scenario 5:** test under different ECIs (Exposure Condition Index) to ensure that the TA-SAR algorithm behaves as expected during ECI switching from one ECI to another. (e.g., head→ body worn)
- **Scenario 6:** test under different transmission antennas to ensure that the TA-SAR algorithm works correctly during antenna switching from one antenna to another
- **Scenario 7:** test under different time windows to ensure that the TA-SAR algorithm functions correctly during time window switching from one time window setting to another. (e.g., time window 100s→60s)
- **Scenario 8:** test under SAR exposure switching between two active radio sets (radio set 1 only, radio set 1+radio set 2, and radio set 2 only) to ensure that the TA-SAR algorithm can control continuity and maintain SAR compliance.

For TA-SAR validation, description of the conducted power measurement test procedures is included in MTK TA-SAR algorithm document, and description of the SAR measurement test procedures is included in MTK TA-SAR algorithm document. In each of the test scenarios, certain test sequence, described in MTK TA-SAR algorithm document, is applied.

For the completeness of verifying that the proposed TA-PD algorithm can realize FCC compliance regarding RF exposure, several test scenarios are constructed as below:

- **Scenario 1:** test under time-varying TX power to verify that the TA-PD algorithm ensures PD compliance through dynamic TX power.
- **Scenario 2:** test under different transmission beams to ensure TA-PD algorithm control works correctly during beam switching from one beam to another.
- **Scenario 3:** test under SAR-and-PD exposure switching to ensure TA-SAR/TA-PD algorithm control correctness and prove the normalized total RF exposure is less than 1.
- **Scenario 4:** test under Multi-SPLSR-group vs. PD exposure switching to ensure TA-SAR/TA-PD algorithm control correctness and prove the normalized total RF exposure is less than 1.

For the TA-PD algorithm validation, the description of the radiated-power measurement test procedures is included in MTK TA-PD algorithm document, and the description of the PD measurement test procedures is included in MTK TA-PD algorithm document.

4. TA-SAR Validation via Conducted Power Measurements

4.1 Measurement Setup

The call boxes KeySight UXM (supporting sub6 NR and LTE) and Rohde & Schwarz CMW500 (supporting LTE, WCDMA, C2K and 2G) are used to validate the proposed TA-SAR mechanism. Figure below shows the block diagram of the measurement bench, which supports the following test scenarios.

- Test scenario 1: range of TA-SAR parameters
- Test scenario 2: time-varying TX power
- Test scenario 3: call disconnection and re-establishment
- Test scenario 5: ECI change

For these measurements, RF port of the call box is connected to the EUT's antenna port through a directional coupler, and the call box establishes a connection link through the test script console tool and the power meter measures the conducted output power of the EUT

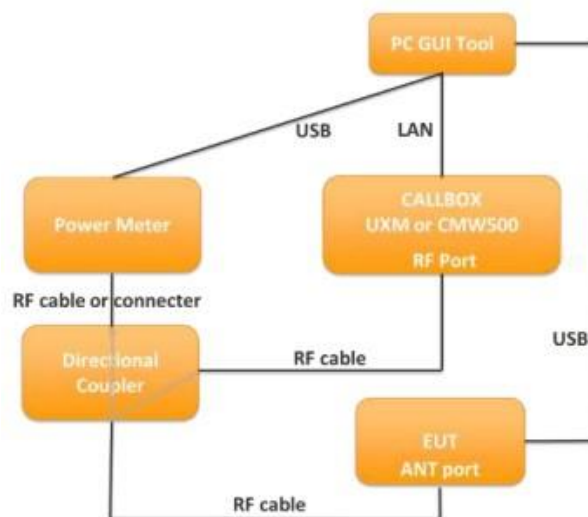


Figure of 5 TA-SAR Gen2 conductive power test setup block diagram for scenarios 1/2/3/5 for WWAN

Figure below shows the block diagram of the measurement bench, which supports test scenario 6 (antenna switching) and test scenario 7 (time window switching). For these measurements, the RF port of the call box is connected with a 1-to-2 power divider and two EUT's antenna ports are individually connected with a RF cable, which allows the call box to transmit/receive signals from the two different system configurations set in these test scenarios. as seen in the figure.

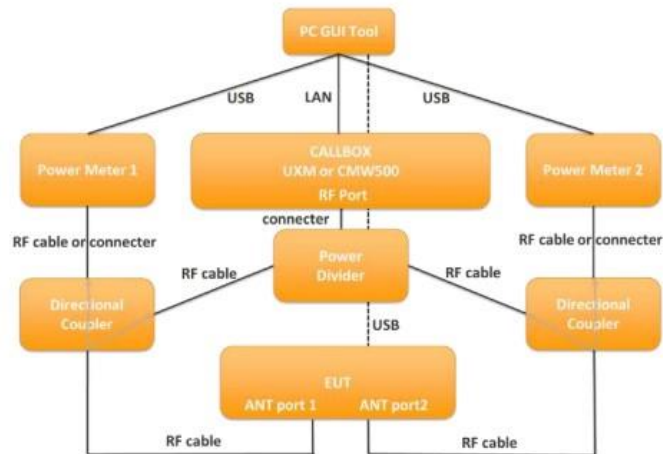


Figure of TA-SAR conductive power test setup block diagram for scenarios 6/7 for WWAN

Figure below shows the setup of WWAN for test scenario 4 (band handover) with different RATs and test scenario 8 (SAR exposure switching). Since two RATs/bands need to be controlled in these two scenarios, RF port of RAT/band #1 and RF port of RAT/band #2 of the call box are individually connected to an antenna port of the EUT through a directional coupler. It is noted that each of the two RATs/bands individually transmits signals through one antenna port.

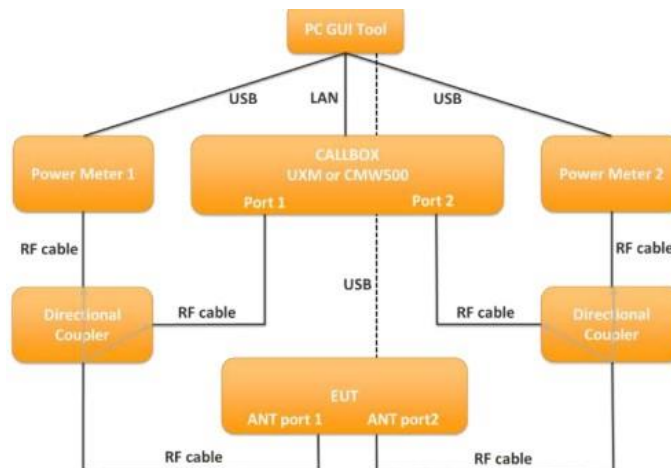


Figure of TA-SAR conductive power test setup block diagram for scenarios 4/8 for WWAN

Figure below shows the setup for test scenario 8 (SAR exposure switching) with three antennas transmitting at the same time. Since three bands (or two bands) need to be controlled individually in this scenario, the three RF ports of the call box are individually connected to the three antenna ports of the EUT through three directional couplers. The EUT can transmit signals of a specific band via each connected port.

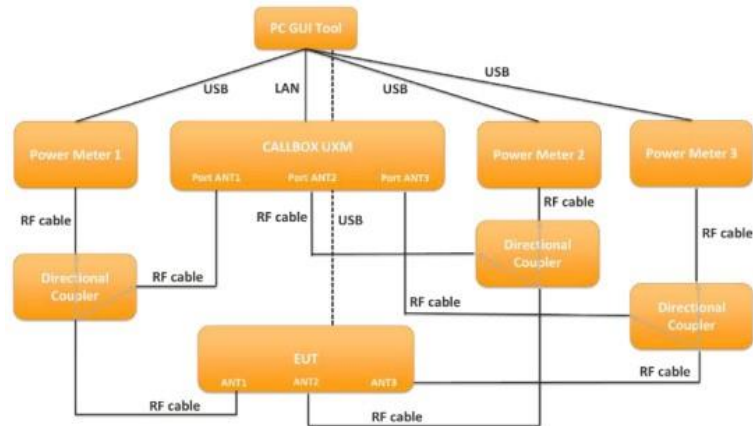


Figure of TA-SAR conductive power test setup block diagram for scenario 8, 3TX for WWAN

4.2 Test Sequences for all scenarios

Three test sequences having possibly time-varying TX power are predefined for TA-SAR validation:

Test sequence 0: EUT's TX power is requested to be maximum.

Test sequence 1: EUT's TX power is requested to be at power less than $P_{sub6_limit} - 0.5\text{dB}$ for 300s, then at maximum power for 200s, and finally at $P_{sub6_limit} - 2.5\text{dB}$ for the remaining time.

Test sequence 2: EUT's TX power to vary with time. This sequence is generated based on the measured PUE_max , measured P_{sub6_limit} and calculated $PUE_backoff$ (= measured P_{sub6_limit} in dBm $PUE_backoff_offset$ in dB) of the EUT.

The test sequences 0, 1, and 2 are illustrated in Figure 4-2-1/2/3, respectively. Furthermore, the three test sequences are respectively tabulated in Table 4-2-1/2/3.

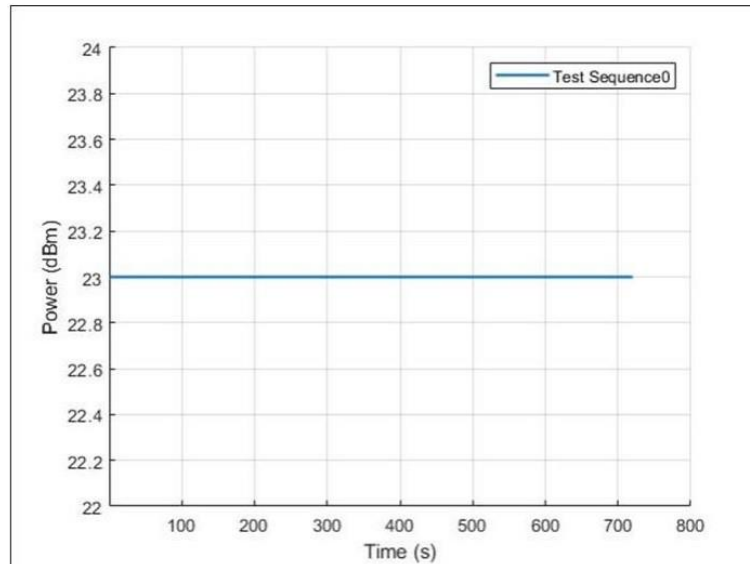
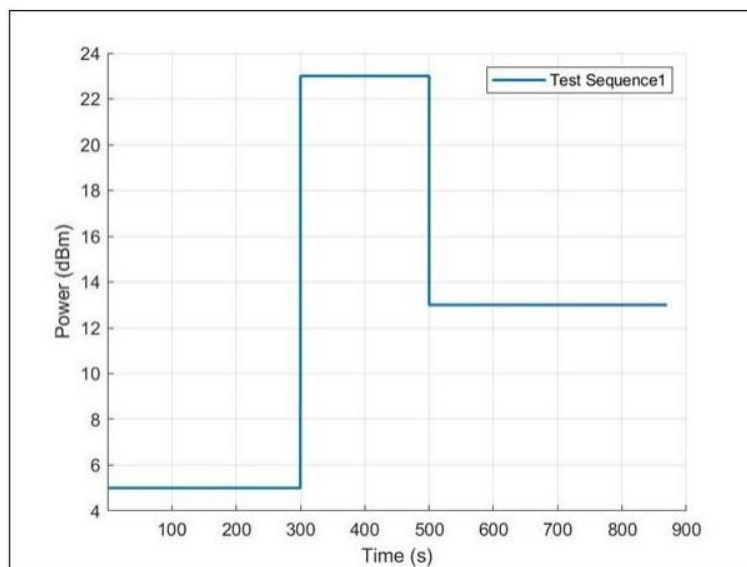


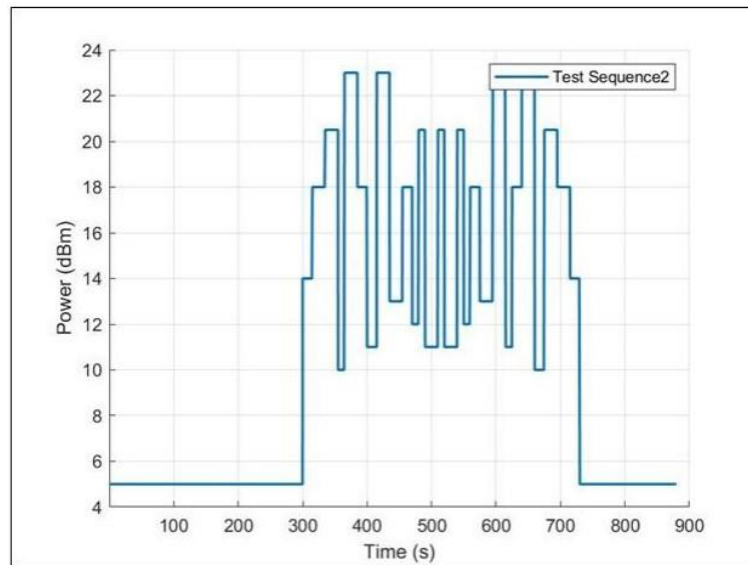
Figure 4-2-1 Test sequence 0

Table 4-2-1 Test sequence 0

Time	Duration	Power (dBm)	Note
720	720	23	PUE_max


Figure 4-2-2 Test sequence 1
Table 4-2-2 Test sequence 1

Time	Duration	Power (dBm)	Note
300	300	5	< Psub6_limit – 0.5dB
500	200	12	PUE_max
870	370	13	Psub6_limit – 2.5dB


Figure 4-2-3 Test sequence 2
Table 4-2-3 Test sequence 2

Time	Duration	Power (dBm)	Note
300	300	5	< Psub6_limit – 0.5dB
315	15	14	Psub6_limit - 4dB
335	20	18	Psub6_limit
355	20	20.5	(Psub6_limit+PUE_max)/2
365	10	10	Psub6_limit - 8dB
385	20	23	PUE_max
400	15	18	Psub6_limit
415	15	11	Psub6_limit - 7dB
435	20	23	PUE_max
455	20	13	Psub6_limit - 5dB
470	15	18	Psub6_limit
480	10	12	Psub6_limit - 6dB
490	10	20.5	(Psub6_limit+PUE_max)/2
510	20	11	Psub6_limit - 7dB
520	10	20.5	(Psub6_limit+PUE_max)/2
540	20	11	Psub6_limit - 7dB
550	10	20.5	(Psub6_limit+PUE_max)/2
560	10	12	Psub6_limit - 6dB
575	15	18	Psub6_limit
595	20	13	Psub6_limit - 5dB
615	20	23	PUE_max
625	10	11	Psub6_limit - 7dB
640	15	18	Psub6_limit
660	20	23	PUE_max
675	15	10	Psub6_limit - 8dB
695	20	20.5	(Psub6_limit+PUE_max)/2
715	20	18	Psub6_limit
730	15	14	Psub6_limit - 4dB
870	140	5	< Psub6_limit – 0.5dB

4.3 Power Limit Table and Test Configurations

For the supported bands/channels/antennas of each technology, the measured power limit (P_{sub6_limit}), corresponding to SAR_design_limit , is listed in the table below. The SAR_design_limit is determined by taking 1-dB device uncertainty into consideration. Please note that for TDD bands with TX duty cycles less than or equal to 100%, the measured power limit corresponds to the burst averaged power level which does not account for TX duty cycle.

Table of Summary table of power limit (P_{sub6_limit}) for all supported RAT

Wireless Technology	Mode	Mode	Antenna	Duty cycle	Head		Hotspot	Body-worn/Extremity		P Max Time-average power (dBm)
					ECI 2	ECI 3	ECI 6	ECI 4	ECI 5	
					Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	
					P limit					
Time-average power (dBm)										
GSM	B850	1TX	Ant0	12.50%	30.80	30.80	21.40	21.40	21.40	23.50
GPRS	B850	1TX	Ant0	12.50%	30.80	30.80	21.40	21.40	21.40	23.50
GPRS	B850	2TX	Ant0	25.00%	30.80	30.80	21.40	21.40	21.40	25.30
GPRS	B850	3TX	Ant0	37.50%	30.80	30.80	21.40	21.40	21.40	26.10
GPRS	B850	4TX	Ant0	50.00%	30.80	30.80	21.40	21.40	21.40	26.30
EGPRS	B850	1TX	Ant0	12.50%	30.80	30.80	21.40	21.40	21.40	17.30
EGPRS	B850	2TX	Ant0	25.00%	30.80	30.80	21.40	21.40	21.40	19.30
EGPRS	B850	3TX	Ant0	37.50%	30.80	30.80	21.40	21.40	21.40	20.10
EGPRS	B850	4TX	Ant0	50.00%	30.80	30.80	21.40	21.40	21.40	20.30
GSM	B850	1TX	Ant1	12.50%	22.40	21.70	24.90	25.40	24.90	23.30
GPRS	B850	1TX	Ant1	12.50%	22.40	21.70	24.90	25.40	24.90	23.30
GPRS	B850	2TX	Ant1	25.00%	22.40	21.70	24.90	25.40	24.90	25.10
GPRS	B850	3TX	Ant1	37.50%	22.40	21.70	24.90	25.40	24.90	25.90
GPRS	B850	4TX	Ant1	50.00%	22.40	21.70	24.90	25.40	24.90	26.10
EGPRS	B850	1TX	Ant1	12.50%	22.40	21.70	24.90	25.40	24.90	17.10
EGPRS	B850	2TX	Ant1	25.00%	22.40	21.70	24.90	25.40	24.90	19.10
EGPRS	B850	3TX	Ant1	37.50%	22.40	21.70	24.90	25.40	24.90	19.90
EGPRS	B850	4TX	Ant1	50.00%	22.40	21.70	24.90	25.40	24.90	20.10
GSM	B1900	1TX	Ant2	12.50%	27.40	27.40	19.50	20.30	19.50	20.40
GPRS	B1900	1TX	Ant2	12.50%	27.40	27.40	19.50	20.30	19.50	20.40
GPRS	B1900	2TX	Ant2	25.00%	27.40	27.40	19.50	20.30	19.50	21.90
GPRS	B1900	3TX	Ant2	37.50%	27.40	27.40	19.50	20.30	19.50	23.20
GPRS	B1900	4TX	Ant2	50.00%	27.40	27.40	19.50	20.30	19.50	23.40
EGPRS	B1900	1TX	Ant2	12.50%	27.40	27.40	19.50	20.30	19.50	16.40
EGPRS	B1900	2TX	Ant2	25.00%	27.40	27.40	19.50	20.30	19.50	18.40
EGPRS	B1900	3TX	Ant2	37.50%	27.40	27.40	19.50	20.30	19.50	19.20
EGPRS	B1900	4TX	Ant2	50.00%	27.40	27.40	19.50	20.30	19.50	19.40
GSM	B1900	1TX	Ant0	12.50%	35.40	35.40	14.40	15.80	14.40	20.20
GPRS	B1900	1TX	Ant0	12.50%	35.40	35.40	14.40	15.80	14.40	20.20
GPRS	B1900	2TX	Ant0	25.00%	35.40	35.40	14.40	15.80	14.40	21.70
GPRS	B1900	3TX	Ant0	37.50%	35.40	35.40	14.40	15.80	14.40	23.00
GPRS	B1900	4TX	Ant0	50.00%	35.40	35.40	14.40	15.80	14.40	23.20
EGPRS	B1900	1TX	Ant0	12.50%	35.40	35.40	14.40	15.80	14.40	16.20
EGPRS	B1900	2TX	Ant0	25.00%	35.40	35.40	14.40	15.80	14.40	18.20
EGPRS	B1900	3TX	Ant0	37.50%	35.40	35.40	14.40	15.80	14.40	19.00
EGPRS	B1900	4TX	Ant0	50.00%	35.40	35.40	14.40	15.80	14.40	19.20
WCDMA	B2	RMC12.2	Ant2	100.00%	25.70	24.40	18.30	19.20	18.30	24.50
WCDMA	B2	RMC12.2	Ant0	100.00%	34.80	34.80	14.00	14.90	14.00	23.90
WCDMA	B4	RMC12.2	Ant2	100.00%	28.30	28.30	19.70	20.90	19.70	24.50
WCDMA	B4	RMC12.2	Ant0	100.00%	33.20	33.20	14.20	15.60	14.20	23.90



WCDMA	B5	RMC12.2	Ant0	100.00%	30.00	30.00	20.50	20.50	20.50	24.50
WCDMA	B5	RMC12.2	Ant1	100.00%	21.70	21.00	24.10	24.80	24.10	23.90
LTE	B2	PC3	Ant2	100.00%	25.50	23.90	17.70	19.10	17.70	24.00
LTE	B2	PC3	Ant0	100.00%	46.90	46.90	14.20	15.00	14.20	23.90
LTE	B2	PC3	Ant1	100.00%	16.40	16.20	17.70	18.40	17.70	24.00
LTE	B2	PC3	Ant5	100.00%	16.90	15.70	16.20	17.60	16.20	23.90
LTE	B4	PC3	Ant2	100.00%	28.70	28.70	19.40	19.70	19.40	24.00
LTE	B4	PC3	Ant0	100.00%	37.90	37.90	13.90	15.90	13.90	23.90
LTE	B4	PC3	Ant1	100.00%	20.00	19.20	20.50	21.20	20.50	24.00
LTE	B4	PC3	Ant5	100.00%	17.60	16.30	16.40	17.80	16.40	23.90
LTE	B5 / 5B	PC3	Ant0	100.00%	29.20	29.20	20.50	20.50	20.50	24.00
LTE	B5 / 5B	PC3	Ant1	100.00%	22.80	22.00	24.50	25.30	24.50	23.90
LTE	B7 / 7C	PC3	Ant2	100.00%	23.40	22.00	15.80	17.20	15.80	24.00
LTE	B7 / 7C	PC3	Ant0	100.00%	31.50	31.50	15.40	17.10	15.40	24.00
LTE	B12	PC3	Ant0	100.00%	30.00	30.00	22.20	22.20	22.20	24.00
LTE	B12	PC3	Ant1	100.00%	24.10	23.40	25.10	25.80	25.10	23.80
LTE	B13	PC3	Ant0	100.00%	29.60	29.60	20.60	20.60	20.60	24.00
LTE	B13	PC3	Ant1	100.00%	24.20	23.40	25.50	25.80	25.50	23.80
LTE	B14	PC3	Ant0	100.00%	29.40	29.40	20.90	20.90	20.90	24.00
LTE	B14	PC3	Ant1	100.00%	24.20	23.40	24.40	24.40	24.40	23.80
LTE	B17	PC3	Ant0	100.00%	30.00	30.00	22.20	22.20	22.20	24.00
LTE	B17	PC3	Ant1	100.00%	24.10	23.40	25.10	25.80	25.10	23.80
LTE	B25	PC3	Ant2	100.00%	25.50	23.90	17.70	19.60	17.70	24.00
LTE	B25	PC3	Ant0	100.00%	46.90	46.90	14.20	15.00	14.20	23.90
LTE	B25	PC3	Ant1	100.00%	16.40	16.20	17.70	18.40	17.70	24.00
LTE	B25	PC3	Ant5	100.00%	16.90	15.70	16.20	17.60	16.20	23.90
LTE	B26	PC3	Ant0	100.00%	29.20	29.20	20.50	20.50	20.50	24.00
LTE	B26	PC3	Ant1	100.00%	22.80	22.00	24.50	25.30	24.50	23.90
LTE	B30	PC3	Ant2	100.00%	24.80	23.50	16.30	17.70	16.30	23.50
LTE	B30	PC3	Ant0	100.00%	35.10	35.10	14.30	17.20	14.30	22.60
LTE	B38 / 38C	PC3	Ant2	63.30%	24.50	21.90	16.00	16.30	16.00	22.00
LTE	B38	PC2	Ant2	43.30%	24.50	21.90	16.00	16.30	16.00	22.30
LTE	B38 / 38C	PC3	Ant0	63.30%	32.30	32.30	15.10	15.90	15.10	21.90
LTE	B38	PC2	Ant0	43.30%	32.30	32.30	15.10	15.90	15.10	22.20
LTE	B38 / 38C	PC3	Ant1	63.30%	16.00	15.30	15.70	17.60	15.70	22.00
LTE	B38	PC2	Ant1	43.30%	16.00	15.30	15.70	17.60	15.70	22.30
LTE	B38 / 38C	PC3	Ant5	63.30%	15.80	15.10	15.10	18.50	15.10	21.90
LTE	B38	PC2	Ant5	43.30%	15.80	15.10	15.10	18.50	15.10	22.10
LTE	B41 / 41C	PC3	Ant2	63.30%	24.50	21.90	16.00	16.30	16.00	22.00
LTE	B41	PC2	Ant2	43.30%	24.50	21.90	16.00	16.30	16.00	22.30
LTE	B41 / 41C	PC3	Ant0	63.30%	32.30	32.30	15.10	15.90	15.10	21.90
LTE	B41	PC2	Ant0	43.30%	32.30	32.30	15.10	15.90	15.10	22.20
LTE	B41 / 41C	PC3	Ant1	63.30%	16.00	15.30	15.70	17.60	15.70	22.00
LTE	B41	PC2	Ant1	43.30%	16.00	15.30	15.70	17.60	15.70	22.30
LTE	B41 / 41C	PC3	Ant5	63.30%	15.80	15.10	15.10	18.50	15.10	22.00
LTE	B41	PC2	Ant5	43.30%	15.80	15.10	15.10	18.50	15.10	22.30
LTE	B48	PC3	Ant6	63.30%	26.60	26.60	14.60	16.00	14.60	19.00
LTE	B48	PC3	Ant7	63.30%	29.10	29.10	15.40	16.80	15.40	19.70
LTE	B48	PC3	Ant1	63.30%	15.70	15.00	13.30	15.90	13.30	19.60
LTE	B48	PC3	Ant5	63.30%	17.90	17.20	17.10	17.80	17.10	22.00
LTE	B66 / 66C / 66B	PC3	Ant2	100.00%	28.70	28.70	19.40	19.70	19.40	24.00
LTE	B66 / 66C / 66B	PC3	Ant0	100.00%	37.90	37.90	13.90	15.90	13.90	23.90
LTE	B66 / 66C / 66B	PC3	Ant1	100.00%	20.00	19.20	20.50	21.20	20.50	24.00
LTE	B66 / 66C / 66B	PC3	Ant5	100.00%	17.60	16.30	16.40	17.80	16.40	24.00
LTE	B71	PC3	Ant0	100.00%	30.10	30.10	23.70	23.80	23.70	24.00
LTE	B71	PC3	Ant1	100.00%	23.10	22.40	26.00	26.70	26.00	23.80



NR	n2	PC3	Ant2	100.00%	26.20	26.20	18.10	18.80	18.10	24.00
NR	n2	PC3	Ant0	100.00%	38.20	38.20	14.00	15.00	14.00	23.90
NR	n2	PC3	Ant1	100.00%	16.90	16.70	17.70	18.40	17.70	24.00
NR	n2	PC3	Ant5	100.00%	17.60	16.90	16.90	18.30	16.90	23.90
NR	n5	PC3	Ant0	100.00%	29.80	29.10	20.70	20.70	20.70	24.00
NR	n5	PC3	Ant1	100.00%	22.80	22.80	25.00	25.80	25.00	23.90
NR	n7	PC3	Ant2	100.00%	23.60	22.20	15.80	16.80	15.80	24.00
NR	n7	PC3	Ant0	100.00%	29.00	29.00	15.50	16.90	15.50	24.00
NR	n12	PC3	Ant0	100.00%	30.80	30.10	22.80	22.80	22.80	24.00
NR	n12	PC3	Ant1	100.00%	23.30	22.60	26.10	26.40	26.10	23.80
NR	n13	PC3	Ant0	100.00%	30.10	29.30	21.30	21.30	21.30	24.00
NR	n13	PC3	Ant1	100.00%	24.40	23.70	23.70	25.10	23.70	23.80
NR	n14	PC3	Ant0	100.00%	30.20	29.50	21.40	21.60	21.40	24.00
NR	n14	PC3	Ant1	100.00%	23.30	22.90	26.10	26.20	26.10	23.80
NR	n25	PC3	Ant2	100.00%	26.20	26.20	18.10	18.80	18.10	24.00
NR	n25	PC3	Ant0	100.00%	38.20	38.20	14.00	15.00	14.00	23.90
NR	n25	PC3	Ant1	100.00%	16.90	16.70	17.70	18.40	17.70	24.00
NR	n25	PC3	Ant5	100.00%	17.60	16.90	16.90	18.30	16.90	23.90
NR	n26	PC3	Ant0	100.00%	29.80	29.10	20.70	20.70	20.70	24.00
NR	n26	PC3	Ant1	100.00%	22.80	22.80	25.00	25.80	25.00	23.90
NR	n30	PC3	Ant2	100.00%	25.90	25.90	16.20	18.20	16.20	23.50
NR	n30	PC3	Ant0	100.00%	36.00	36.00	14.50	17.10	14.50	22.60
NR	n38	PC3	Ant2	100.00%	23.80	22.60	16.20	17.60	16.20	24.00
NR	n38	PC3	Ant0	100.00%	31.60	31.60	14.80	16.10	14.80	23.90
NR	n38	PC3	Ant1	100.00%	17.30	16.60	17.20	20.00	17.20	24.00
NR	n38	PC3	Ant5	100.00%	16.50	16.50	15.70	18.30	15.70	23.90
NR	n41 / n41C / n41B	PC3	Ant2	100.00%	23.80	22.60	16.20	17.60	16.20	24.00
NR	n41	PC2	Ant2	50.00%	23.80	22.60	16.20	17.60	16.20	22.90
NR	n41	PC1.5	Ant2	25.00%	23.80	22.60	16.20	17.60	16.20	19.90
NR	n41 / n41C / n41B	PC3	Ant0	100.00%	31.60	31.60	14.80	16.10	14.80	23.90
NR	n41	PC2	Ant0	50.00%	31.60	31.60	14.80	16.10	14.80	22.80
NR	n41	PC1.5	Ant0	25.00%	31.60	31.60	14.80	16.10	14.80	19.80
NR	n41 / n41C / n41B	PC3	Ant1	100.00%	17.30	16.60	17.20	20.00	17.20	24.00
NR	n41	PC2	Ant1	50.00%	17.30	16.60	17.20	20.00	17.20	22.90
NR	n41	PC1.5	Ant1	25.00%	17.30	16.60	17.20	20.00	17.20	19.90
NR	n41 / n41C / n41B	PC3	Ant5	100.00%	16.50	16.50	15.70	18.30	15.70	24.00
NR	n41	PC2	Ant5	50.00%	16.50	16.50	15.70	18.30	15.70	22.90
NR	n41	PC1.5	Ant5	25.00%	16.50	16.50	15.70	18.30	15.70	19.90
NR	n48	PC3	Ant6	100.00%	27.00	27.00	14.30	16.60	14.30	21.00
NR	n48	PC3	Ant7	100.00%	25.90	25.90	14.90	17.20	14.90	21.70
NR	n48	PC3	Ant1	100.00%	19.30	18.50	16.50	19.40	16.50	21.60
NR	n48	PC3	Ant5	100.00%	18.10	17.40	18.40	19.10	18.40	23.50
NR	n66	PC3	Ant2	100.00%	28.50	28.50	19.30	20.00	19.30	24.00
NR	n66	PC3	Ant0	100.00%	33.50	33.50	14.40	15.80	14.40	23.90
NR	n66	PC3	Ant1	100.00%	19.30	18.60	20.70	21.40	20.70	24.00
NR	n66	PC3	Ant5	100.00%	18.80	18.10	17.10	18.00	17.10	23.90
NR	n70	PC3	Ant2	100.00%	28.80	28.80	20.00	20.00	20.00	23.80
NR	n70	PC3	Ant0	100.00%	34.10	34.10	15.50	15.80	15.50	23.70
NR	n70	PC3	Ant1	100.00%	21.40	20.70	23.00	23.70	23.00	23.80
NR	n70	PC3	Ant5	100.00%	18.30	16.90	17.10	18.50	17.10	23.60
NR	n71	PC3	Ant0	100.00%	30.40	29.70	22.80	23.20	22.80	24.00
NR	n71	PC3	Ant1	100.00%	24.30	23.50	27.20	27.50	27.20	23.80
NR	n77 / n77C	PC3	Ant6	100.00%	24.60	21.50	13.00	14.40	13.00	24.00
NR	n77	PC2	Ant6	50.00%	24.60	21.50	13.00	14.40	13.00	23.00
NR	n77	PC1.5	Ant6	25.00%	24.60	21.50	13.00	14.40	13.00	20.00
NR	n77 / n77C	PC3	Ant7	100.00%	25.40	25.40	14.70	17.20	14.70	23.50

NR	n77	PC2	Ant7	50.00%	25.40	25.40	14.70	17.20	14.70	22.50
NR	n77	PC1.5	Ant7	25.00%	25.40	25.40	14.70	17.20	14.70	19.50
NR	n77 / n77C	PC3	Ant1	100.00%	14.60	13.90	13.30	16.30	13.30	24.00
NR	n77	PC2	Ant1	50.00%	14.60	13.90	13.30	16.30	13.30	23.00
NR	n77	PC1.5	Ant1	25.00%	14.60	13.90	13.30	16.30	13.30	20.00
NR	n77 / n77C	PC3	Ant5	100.00%	17.30	16.60	17.20	17.90	17.20	24.00
NR	n77	PC2	Ant5	50.00%	17.30	16.60	17.20	17.90	17.20	23.00
NR	n77	PC1.5	Ant5	25.00%	17.30	16.60	17.20	17.90	17.20	20.00
NR	n78	PC3	Ant6	100.00%	24.60	21.50	13.00	14.40	13.00	24.00
NR	n78	PC2	Ant6	50.00%	24.60	21.50	13.00	14.40	13.00	23.00
NR	n78	PC1.5	Ant6	25.00%	24.60	21.50	13.00	14.40	13.00	20.00
NR	n78	PC3	Ant7	100.00%	25.40	25.40	14.70	17.20	14.70	23.50
NR	n78	PC2	Ant7	50.00%	25.40	25.40	14.70	17.20	14.70	22.50
NR	n78	PC1.5	Ant7	25.00%	25.40	25.40	14.70	17.20	14.70	19.50
NR	n78	PC3	Ant1	100.00%	14.60	13.90	13.30	16.30	13.30	24.00
NR	n78	PC2	Ant1	50.00%	14.60	13.90	13.30	16.30	13.30	23.00
NR	n78	PC1.5	Ant1	25.00%	14.60	13.90	13.30	16.30	13.30	20.00
NR	n78	PC3	Ant5	100.00%	17.30	16.60	17.20	17.90	17.20	24.00
NR	n78	PC2	Ant5	50.00%	17.30	16.60	17.20	17.90	17.20	23.00
NR	n78	PC1.5	Ant5	25.00%	17.30	16.60	17.20	17.90	17.20	20.00
NTN	B23	PC3	Ant5	100.00%				22.60		23.50
NTN	B255	PC3	Ant5	100.00%				21.00		23.50

Table for Sub-6GHz TA-SAR validation test case list

Test Case #	Test Scenario	Test Configuration
1	1.Range of TA-SAR-parameters	FR1 n77
2	2.Time-varting TX power	GSM850
3		GSM1900
4		WCDMA II
5		WCDMA V
6		LTE B26
7		LTE B66
8		FR1 n12
9		FR1 n77
10	3.Call disconnection and re-establishment	FR1 n77
11	4. Band handover / 6. Antenna Switch	LTE Band 48 Ant6 to WCDMA II Ant 0
12	5. ECI(Exposure Condition Index)	LTE B66 ECI 6 to ECI 6
13	7.Time window switching 60s-100s-60s	LTE B66 to LTE B48
14	7.Time window switching 100s-60s-100s	LTE B48 to LTE B66
15	8.SAR exposure switching	LTE B66 to FR1 n77
16	IoT NTN Max power	NTN B255

Table below summarizes the test configurations of all RATs, and the corresponding worst-case measured SAR for each RAT under the power limit.

Table of Test configurations of radio technologies and worst-case measured SAR

Test Case	Test Scenario	Test Band	Configure	Test Position Gap (mm)	ANT	ECI	Channel	Part 1 @Plimit 1-g / 10g SAR (W/kg)	Part 2 Test Result 1-g / 10g SAR (W/kg)	1g/10g SAR Limit. (W/kg)
1	1. Range of TA-SAR parameters	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	0.786	0.659	1.6
2	1. IoT-NTN Max power	NTN Band 255	3.75K_BPSK_1_46	Right Edge_0mm	5	4	261505	2.32	1.84	4
3	2. Time-varying TX power Seq 1	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	0.66	0.553	1.6
4	2. Time-varying TX power Seq 2	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	0.66	0.671	1.6
5	2. Time-varying TX power Seq 1	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	0.745	0.657	1.6
6	2. Time-varying TX power Seq 2	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	0.745	0.676	1.6
7	2. Time-varying TX power Seq 1	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	0.845	0.69	1.6
8	2. Time-varying TX power Seq 2	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	0.845	0.69	1.6
9	2. Time-varying TX power Seq 1	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	0.573	0.467	1.6
10	2. Time-varying TX power Seq 2	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	0.573	0.472	1.6
11	2. Time-varying TX power Seq 1	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	0.659	0.566	1.6
12	2. Time-varying TX power Seq 2	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	0.659	0.556	1.6
13	2. Time-varying TX power Seq 1	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805	0.825	1.6
14	2. Time-varying TX power Seq 2	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805	0.717	1.6
15	2. Time-varying TX power Seq 1	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	0.637	0.546	1.6
16	2. Time-varying TX power Seq 2	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	0.637	0.555	1.6
17	2. Time-varying TX power Seq 1	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	0.786	0.684	1.6
18	2. Time-varying TX power Seq 2	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	0.786	0.756	1.6
19	3. Call disconnection and re-establishment	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	0.786	0.825	1.6
Test Case	Test Scenario	Test Band	Configure	Test Position Gap (mm)	ANT	ECI	Channel	Part 1 @Plimit 1-g SAR (W/kg)	Part 2 Test Result Exposure Ratio	Exposure Limit
20	4. Band/RAT handover	LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	0.751	0.472	1
		WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	0.845		
21	5. Change in operating state	LTE Band 66	20M_QPSK_50_50	Back_5mm	0	4	132572	0.585	0.459	1
		LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805		
22	7. Time window switching (100-60-100)	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805	0.612	1
		LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	0.751		
23	7. Time window switching (60-100-60)	LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	0.751	0.443	1
		LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805		
24	8. SAR exposure switching (ENDC)	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	0.805	0.67	1
		FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	0.786		

Table of Test configurations of radio technologies and worst-case measured Plimit and Pmax

Test Case	Test Scenario	Test Band	Configure	Test Position Gap (mm)	ANT	ECI	Channel	Pmax Setting	Plimit Setting	Measured Pmax	Measured Plimit	PUE max cust offset	PUE backoff offset	Unce.
1	1. Range of TA-SAR parameters	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1
2	1. IoT-NTN Max power	NTN Band 255	3.75K_BPSK_1_46	Right Edge_0mm	5	4	261505	23.5	21	23.86	21.48	2	57	1.5
3	2. Time-varying TX power Seq 1	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	26.1	24.9	26.3	24.1	10	3	1
4	2. Time-varying TX power Seq 2	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	26.1	24.9	26.3	24.1	10	3	1
5	2. Time-varying TX power Seq 1	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	23.2	14.4	23.2	13.5	10	3	1
6	2. Time-varying TX power Seq 2	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	23.2	14.4	23.2	13.5	10	3	1
7	2. Time-varying TX power Seq 1	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	23.9	14	23.9	13.5	10	3	1
8	2. Time-varying TX power Seq 2	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	23.9	14	23.9	13.5	10	3	1
9	2. Time-varying TX power Seq 1	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	23.9	21.7	24.09	21.45	10	3	1
10	2. Time-varying TX power Seq 2	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	23.9	21.7	24.09	21.45	10	3	1
11	2. Time-varying TX power Seq 1	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	23.9	22.8	23.8	22.5	10	3	1
12	2. Time-varying TX power Seq 2	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	23.9	22.8	23.8	22.5	10	3	1
13	2. Time-varying TX power Seq 1	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.5	13.78	10	3	1
14	2. Time-varying TX power Seq 2	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.5	13.78	10	3	1
15	2. Time-varying TX power Seq 1	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	24	22.8	24.7	22.9	10	3	1
16	2. Time-varying TX power Seq 2	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	24	22.8	24.7	22.9	10	3	1
17	2. Time-varying TX power Seq 1	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1
18	2. Time-varying TX power Seq 2	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1
19	3. Call disconnection and re-establishment	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1
20	4. Band/RAT handover	LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	19	14.6	19.6	14.7	10	3	1
		WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	23.9	14	23.8	13.6	10	3	1
21	5. Change in operating state	LTE Band 66	20M_QPSK_50_50	Back_5mm	0	4	132572	23.9	15.9	24.5	15.8	10	3	1
		LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.5	13.78	10	3	1
22	7. Time window switching (100-60-100)	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.3	13.78	10	3	1
		LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	19	14.6	19.7	14.6	10	3	1
23	7. Time window switching (60-100-60)	LTE Band 48	20M_QPSK_1_99	Left Edge_5mm	6	6	56640	19	14.6	19.7	14.6	10	3	1
		LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.3	13.78	10	3	1
24	8. SAR exposure switching (ENDC)	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.3	13.78	10	3	1
		FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1

4.4 Measurement Results for Scenario1: Range of TA-SAR Parameters

- Test Case 1: Range of TA-SAR Parameters for FR1 n77

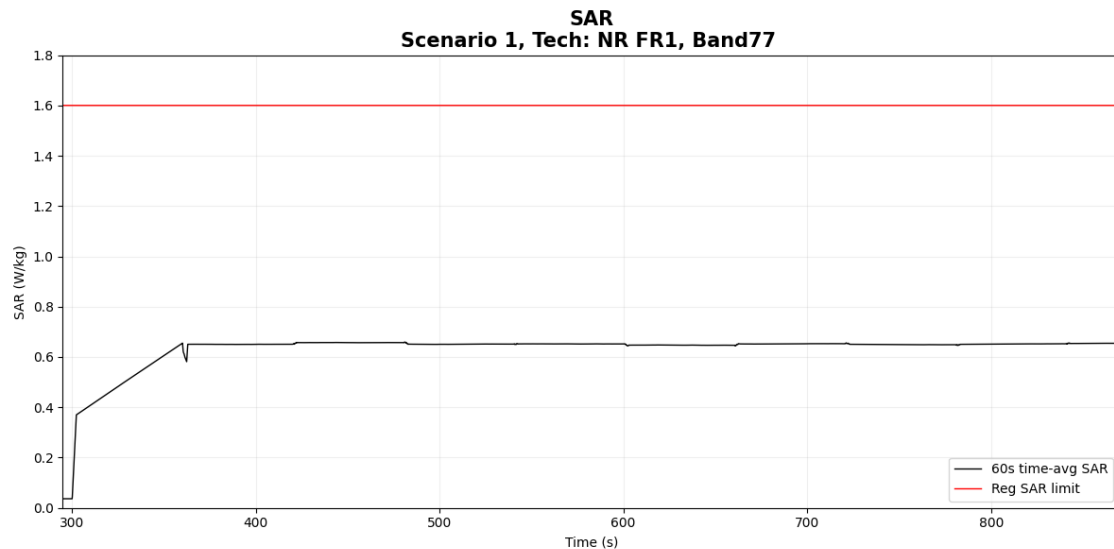


Figure of Time-averaged SAR

Validation result: **pass**

4.5 Measurement Results for Scenario1: NTN Max Power

- Test Case 2: Max Power result for NTN B255

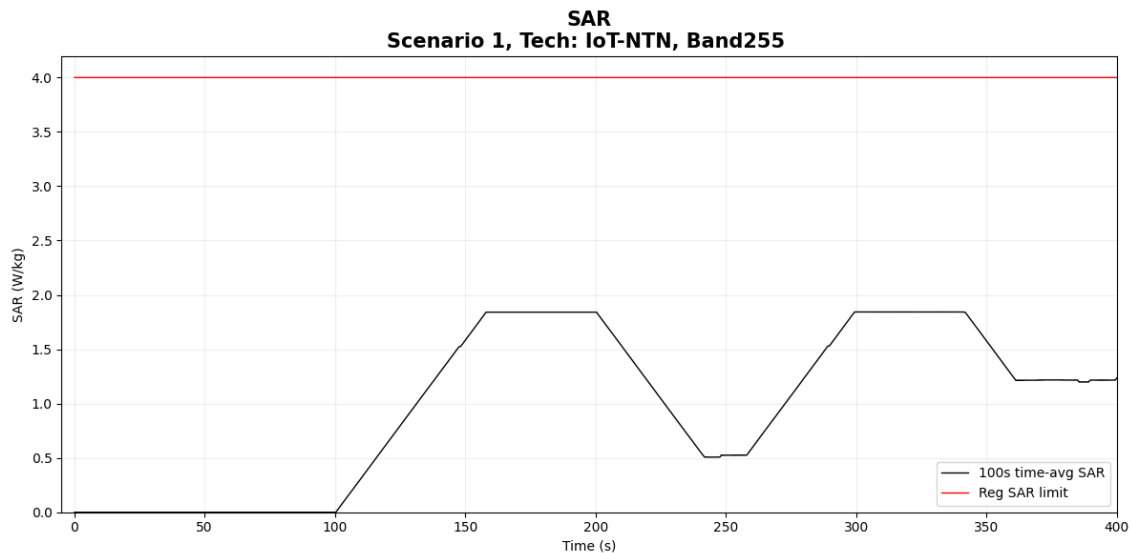
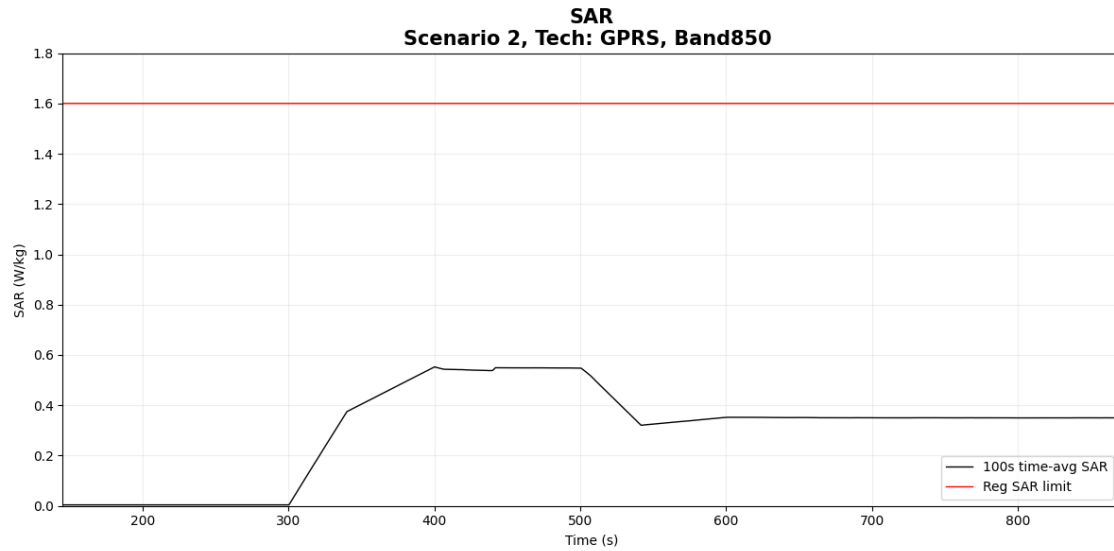


Figure of Time-averaged SAR

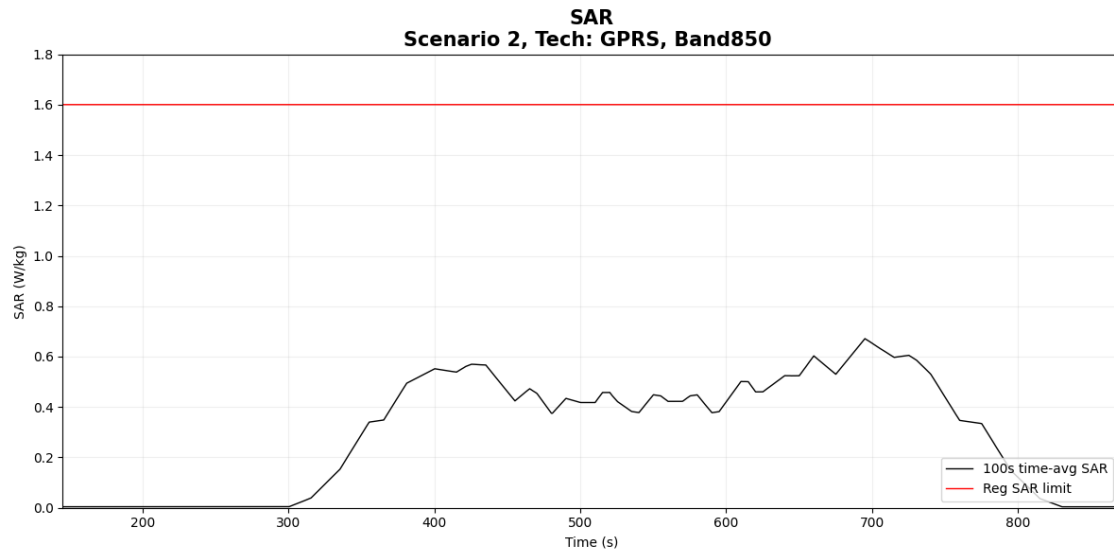
Validation result: **pass**

4.6 Conducted Power Measurement Results for Scenario 2: Time-Varying TX Power

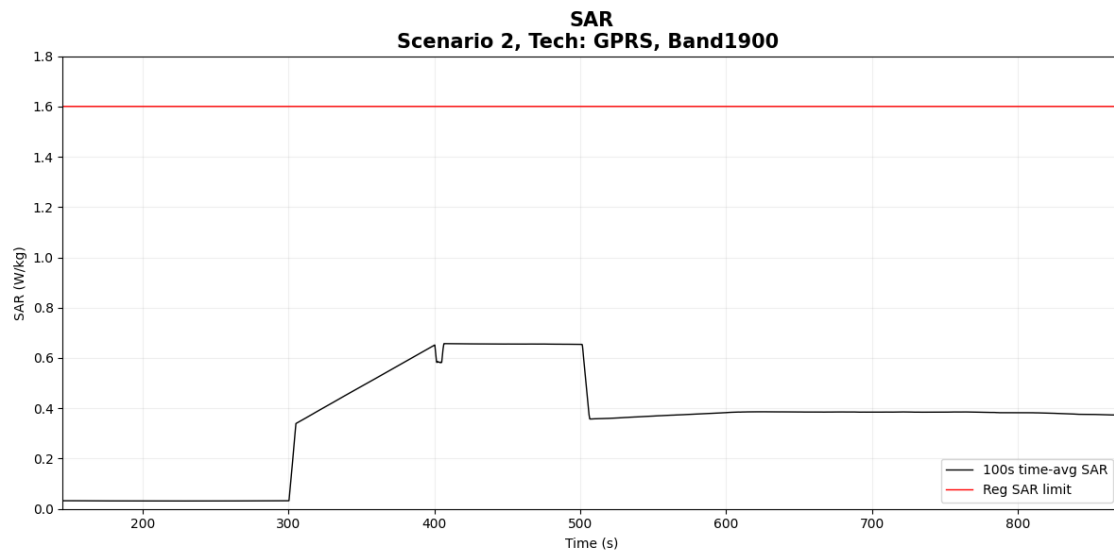
- Test Case 3: GSM850 result for test sequence 1



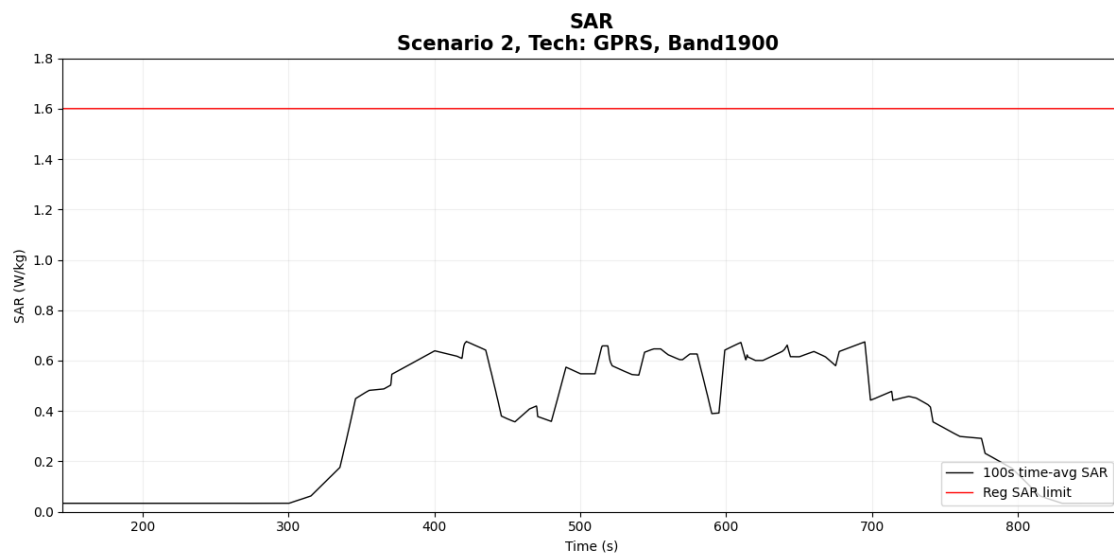
- Test Case 4: GSM850 result for test sequence 2



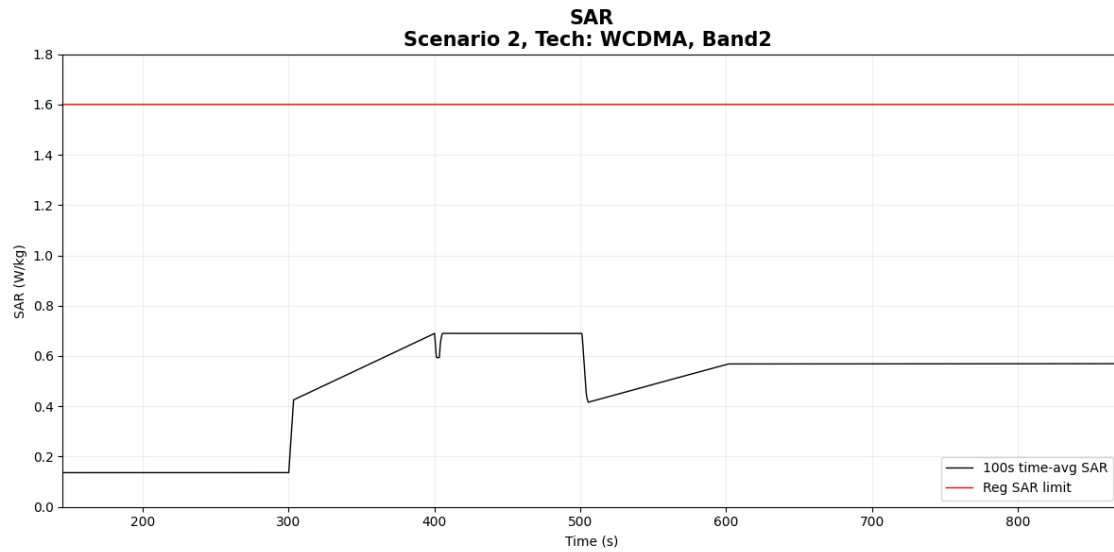
● **Test Case 5: GSM1900 result for test sequence 1**



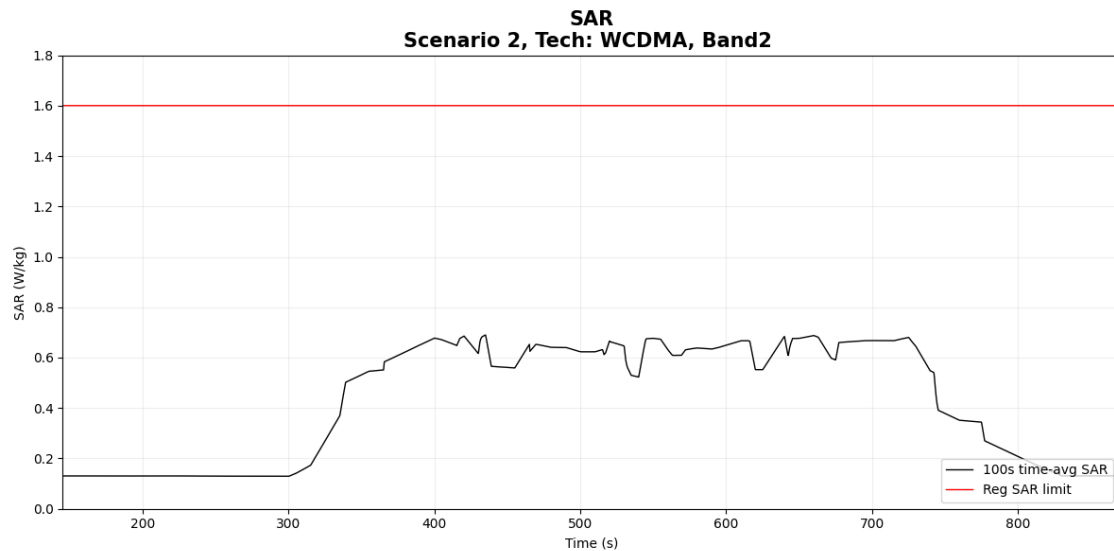
● **Test Case 6: GSM1900 result for test sequence 2**



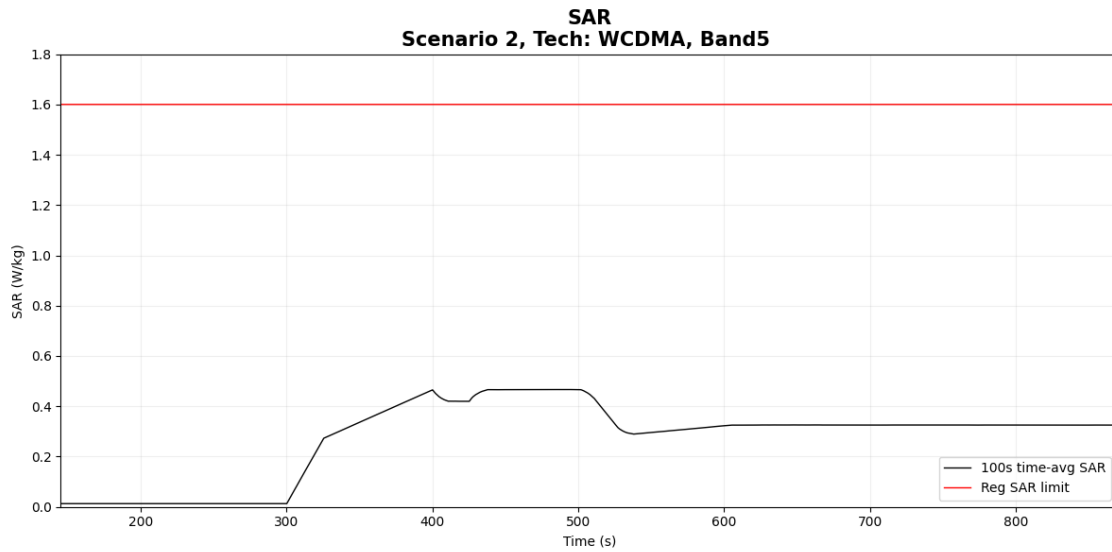
● **Test Case 7: UMTS B2 result for test sequence 1**



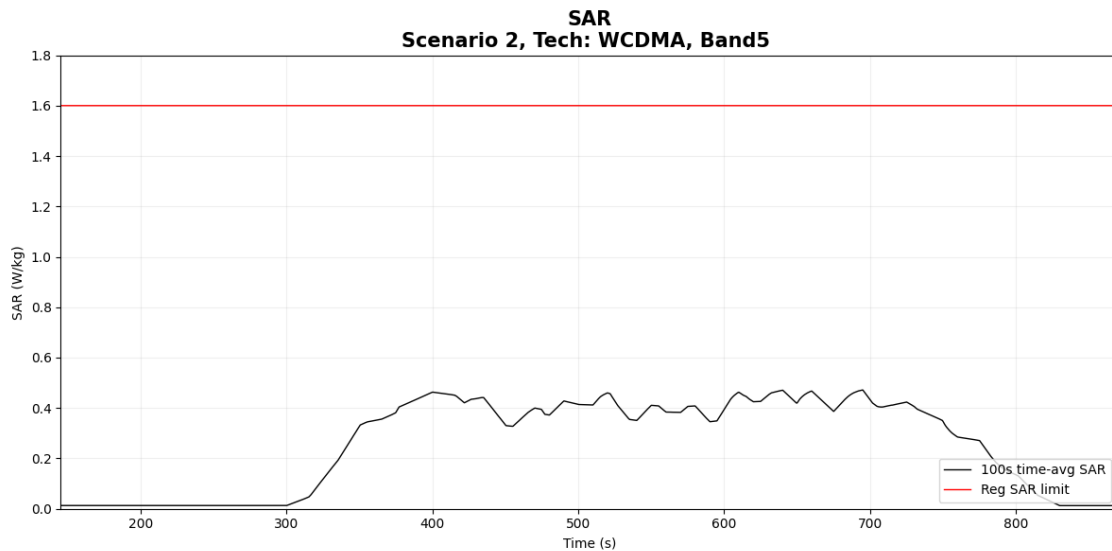
● **Test Case 8: UMTS B2 result for test sequence 2**



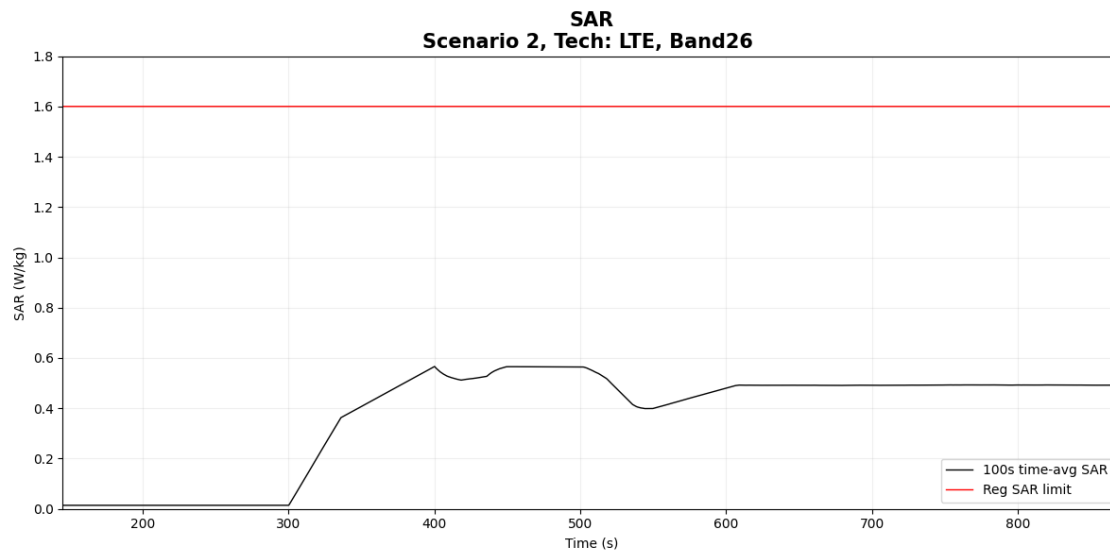
● **Test Case 9: UMTS B5 result for test sequence 1**



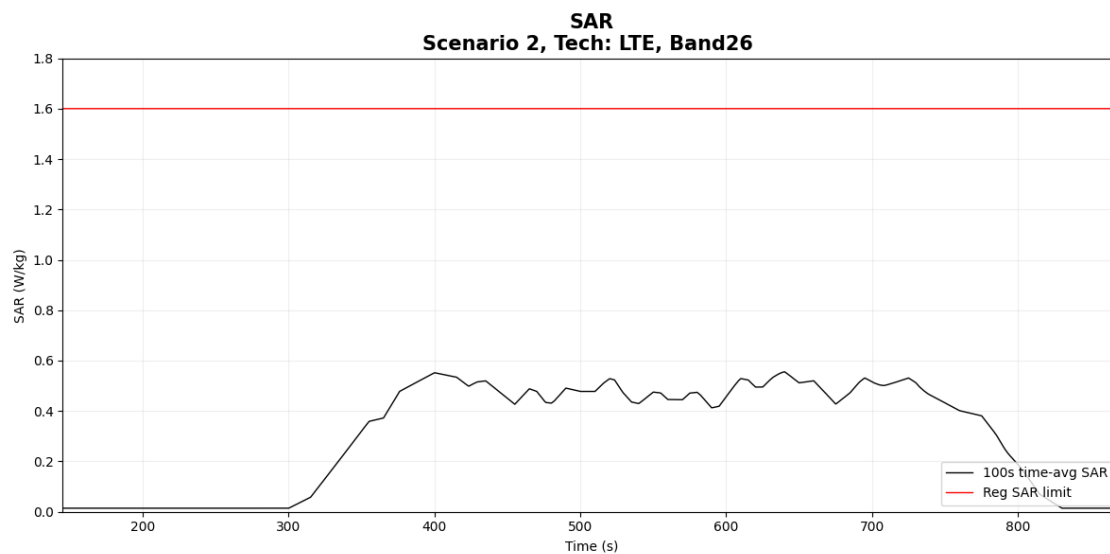
● **Test Case 10: UMTS B5 result for test sequence 2**



● **Test Case 11: LTE B26 result for test sequence 1**



● **Test Case 12: LTE B26 result for test sequence 2**



● **Test Case 13: LTE B66 result for test sequence 1**

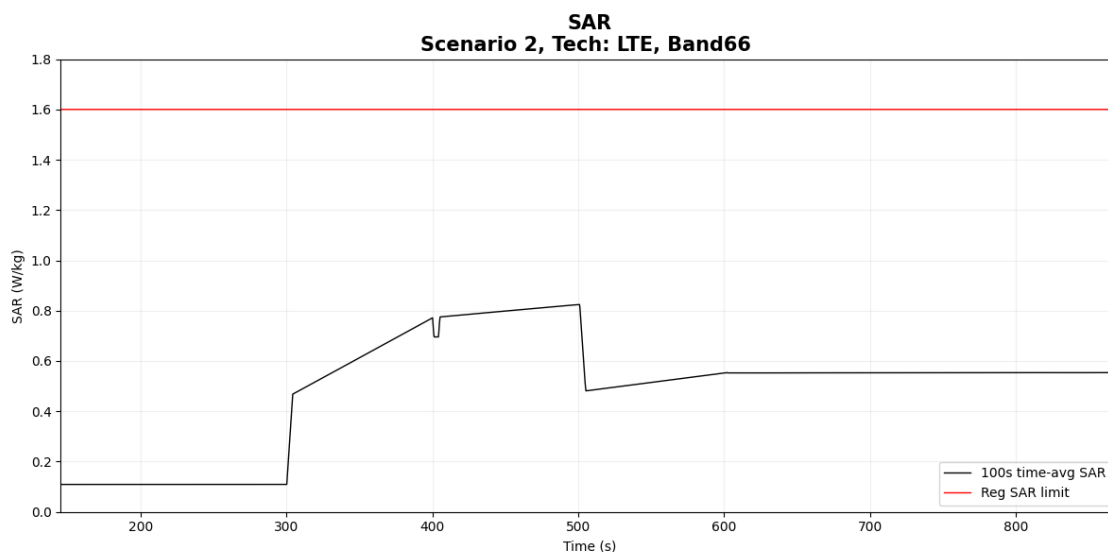


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 14: LTE B66 result for test sequence 2**

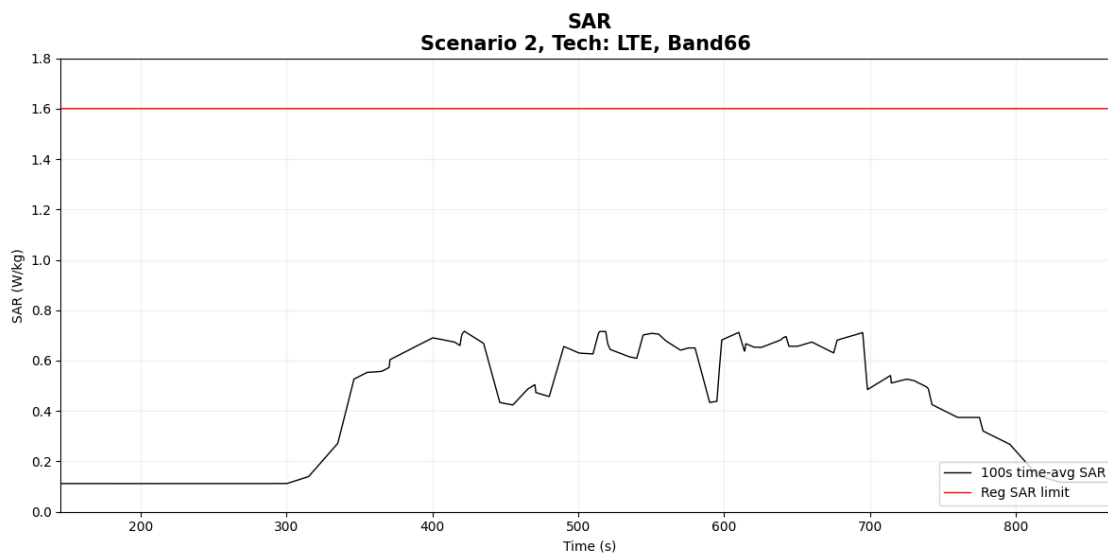
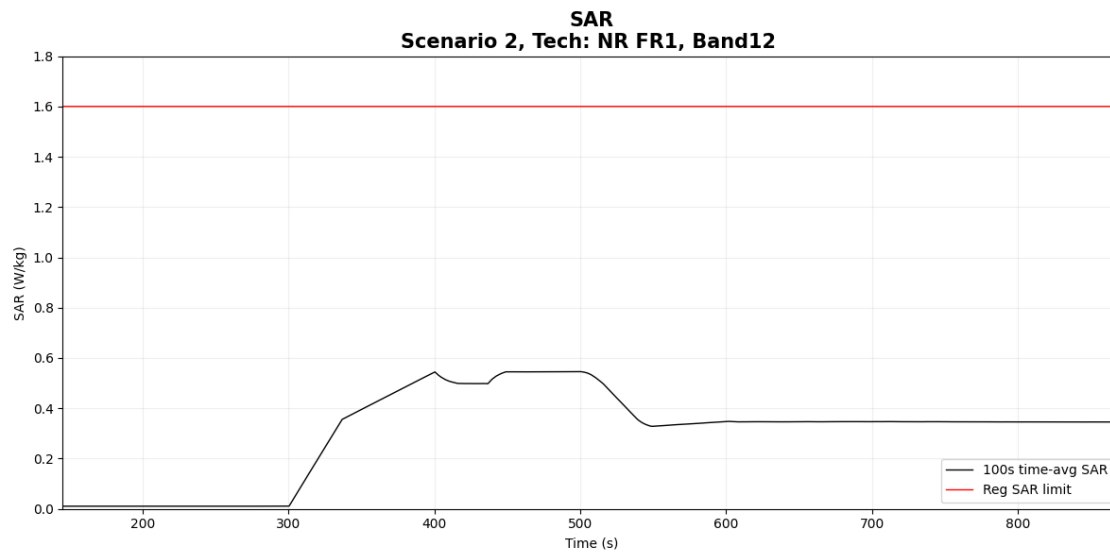


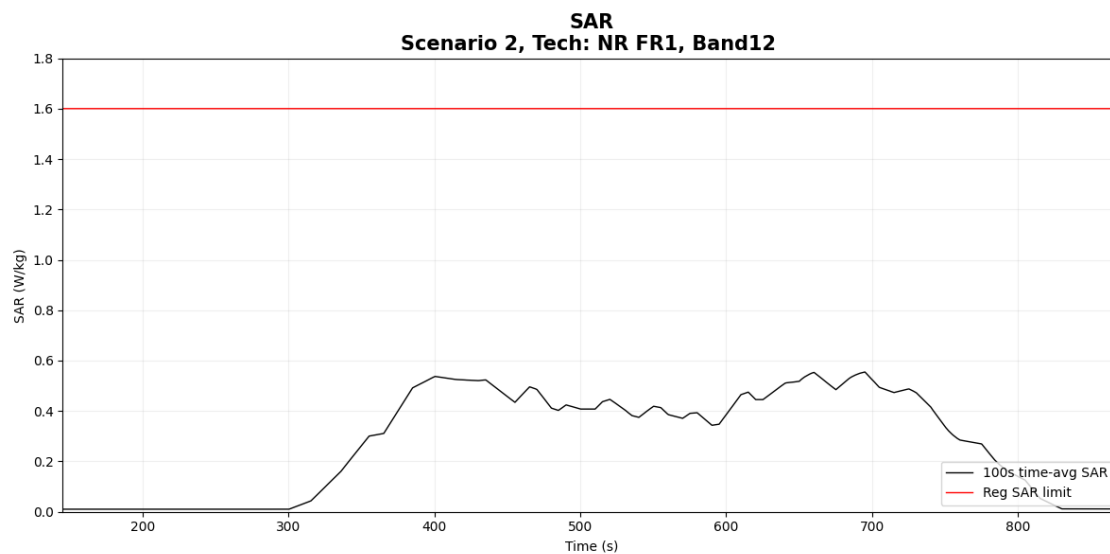
Figure of Time-averaged SAR

Validation result: pass

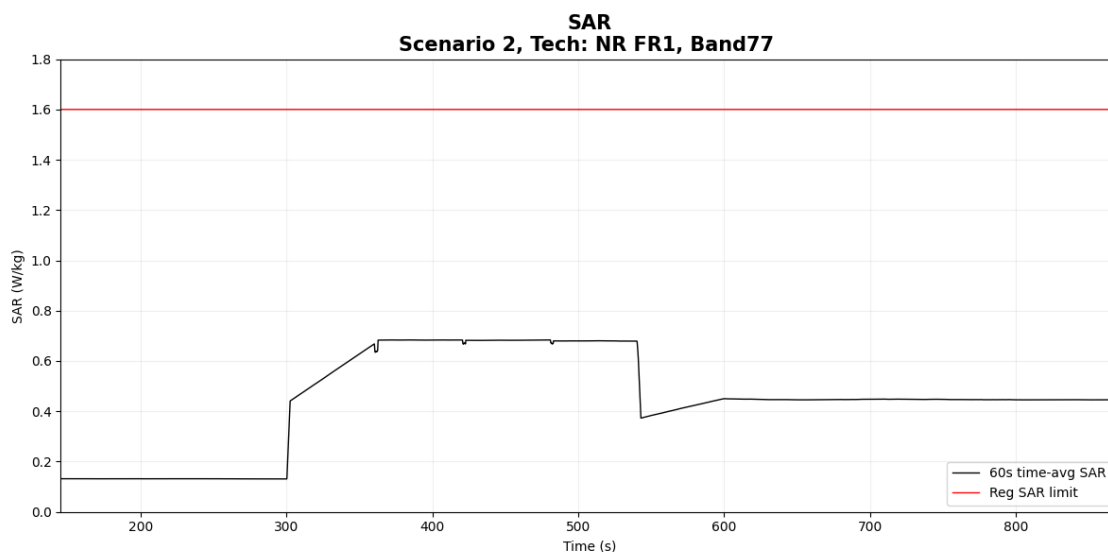
● **Test Case 15: FR1 12 result for test sequence 1**



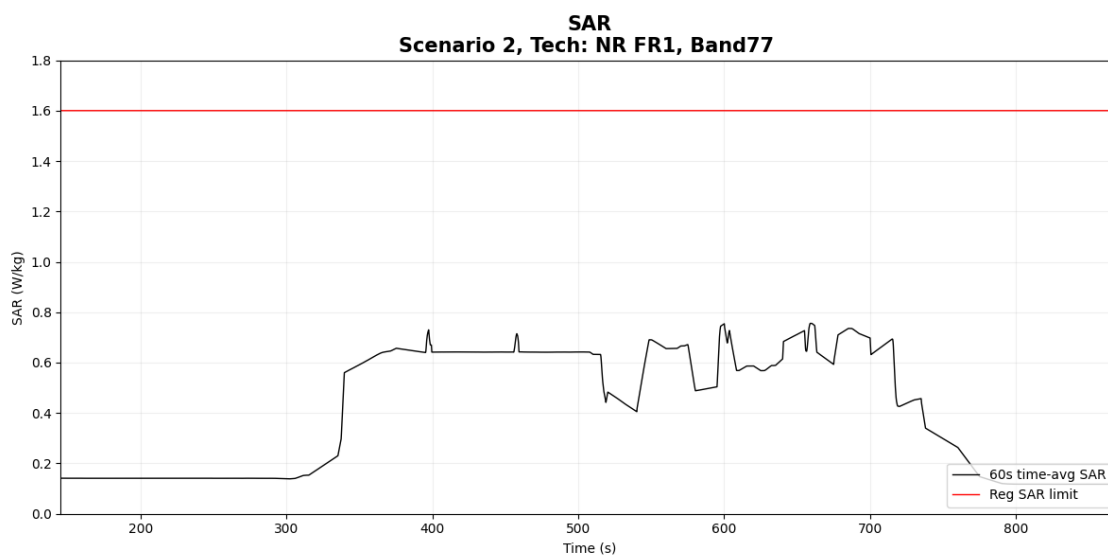
● **Test Case 16: FR1 n12 result for test sequence 2**



- Test Case 17: FR1 77 result for test sequence 1

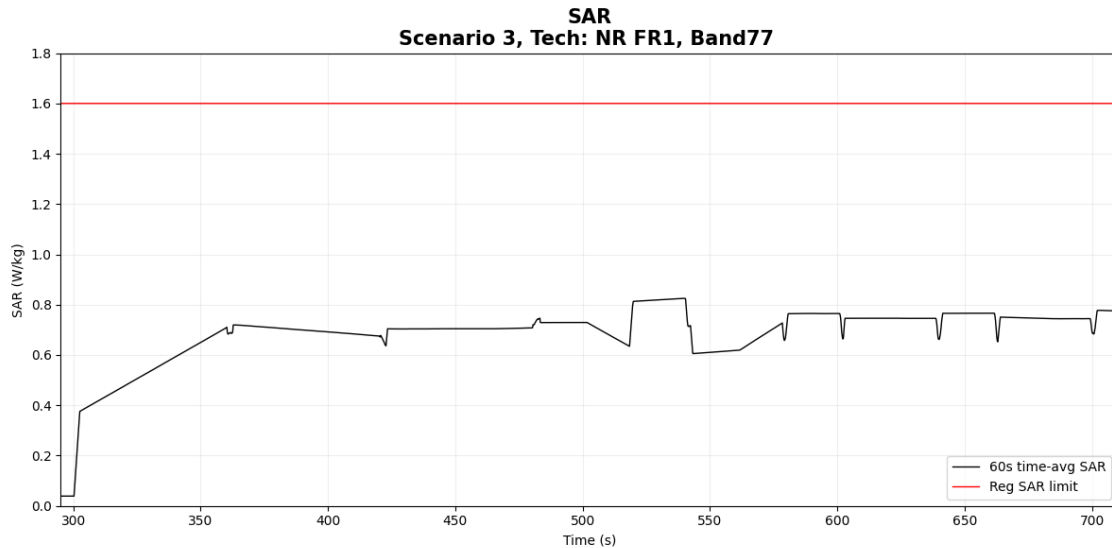


- Test Case 18: FR1 n77 result for test sequence 2



4.7 Conducted Power Measurement Results for Scenario 3: Call Disconnection and Re-establishment

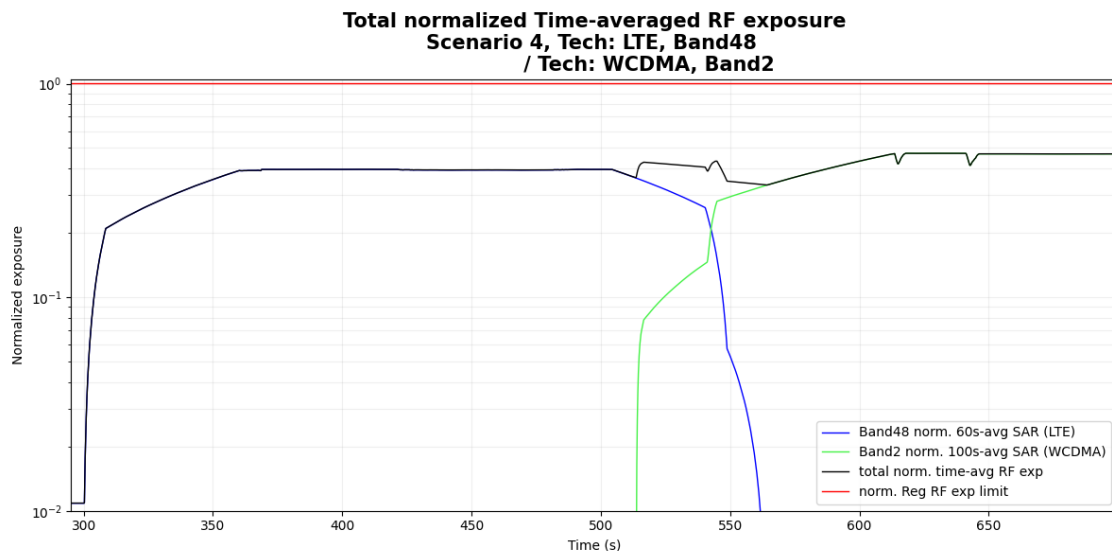
- Test Case 19: FR1 n77 for call drop



Validation result: **pass**

4.8 Conducted Power Measurement Results for Scenario5 Band Handover

- Test Case 20: LTE B48 to UMTS B2 for band handover



Validation result: **pass**

4.9 Conducted Power Measurement Results for Scenario 5: ECI Change

- Test Case 21: LTE B66 for ECI change

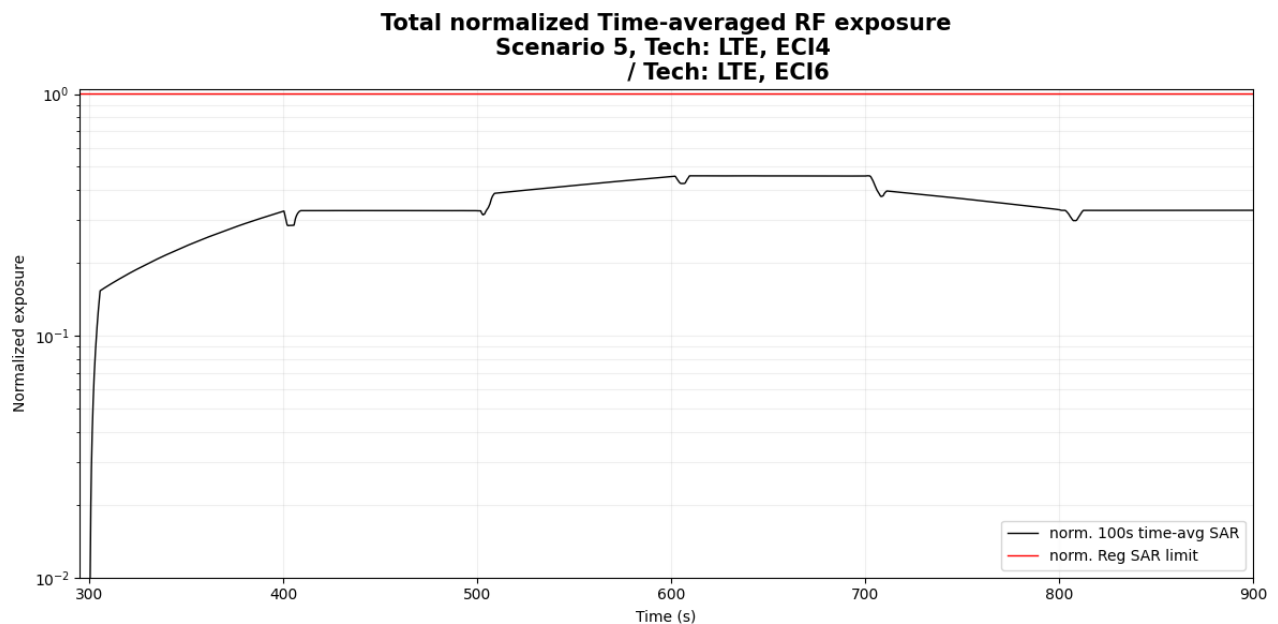
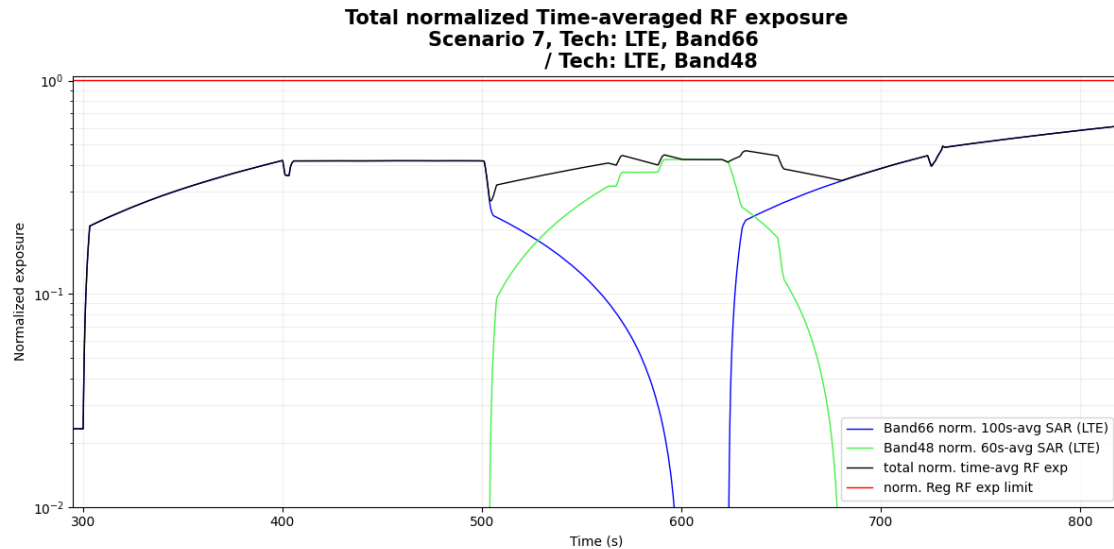


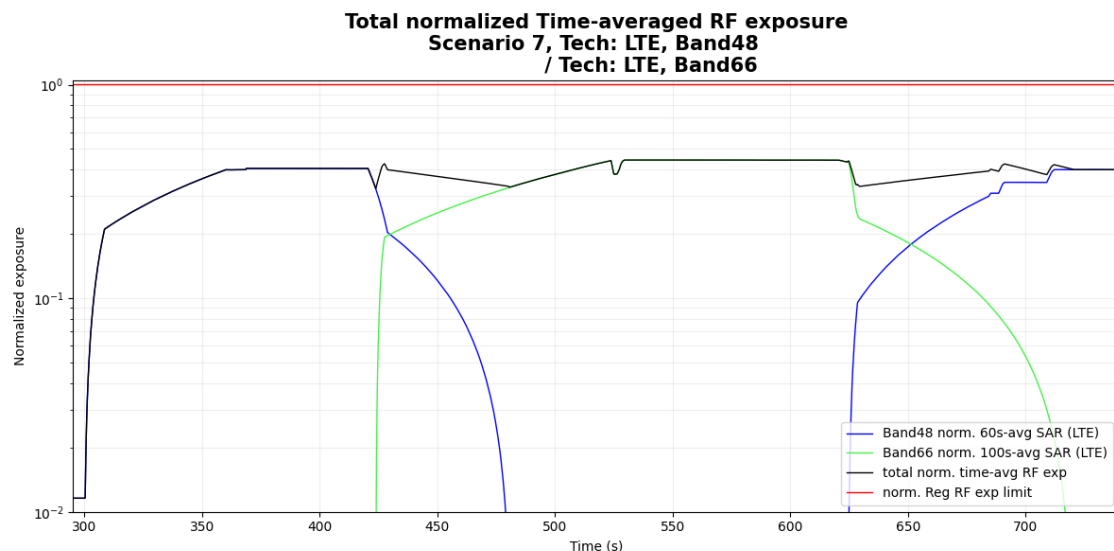
Figure of Normalized time-averaged RF Exposure
Validation result: pass

4.10 Conducted Power Measurement Results for Scenario 7: Time Window Switching

- Test Case 22: Change in time-window from 100s to 60s to 100s



- Test Case 23: Change in time-window from 60s to 100s to 60s



4.11 Conducted Power Measurement Results for Scenario 8: SAR Exposure Switching

- Test Case 24: SAR Exposure Switch for LTE B66 to FR1 n77

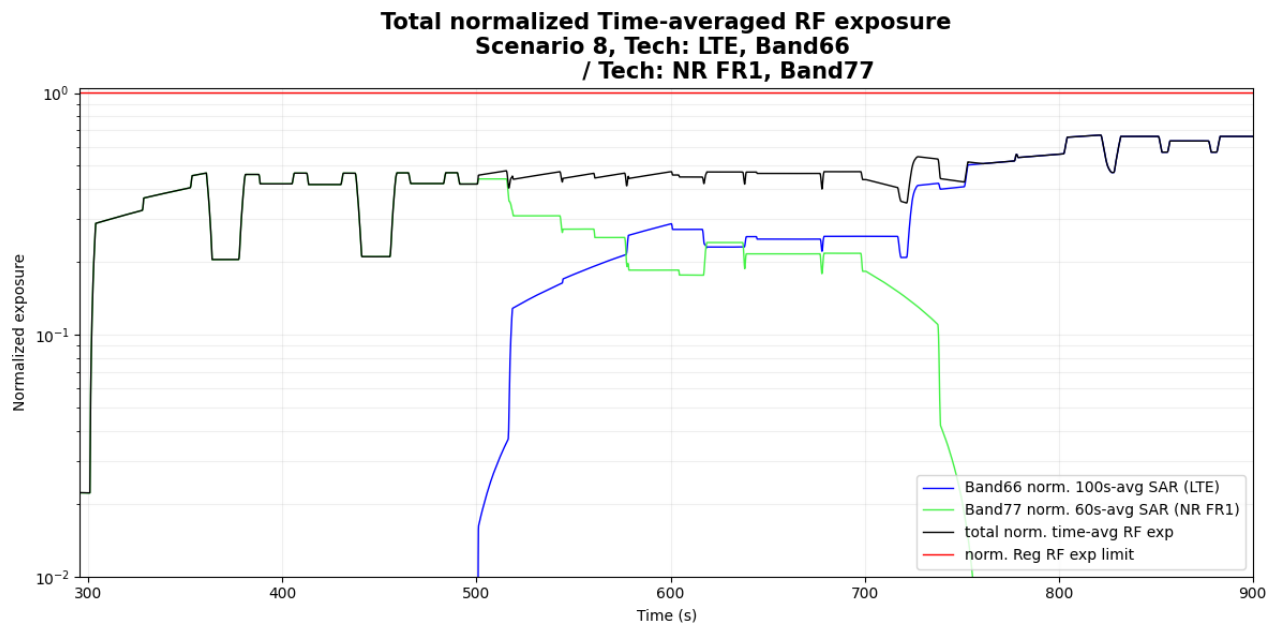


Figure of Normalized time-averaged RF Exposure
Validation result: **pass**

5. TA-SAR Validation via SAR Measurements

5.1 Measurement Setup

The measurement setup is similar to normal fixed power SAR measurement. The difference in SAR measurement setup for time averaging feature validation is that the call box operates under the close loop power control mode and is connected to the PC, so that the PC can control the call box based on the test sequence to configure EUT's TX target power. The same test procedure used in the conducted power setup for time-varying TX power measurement is also used in this section for time-averaging SAR measurements. Since the SAR chamber is an uncontrolled environment, the path loss between the call box antenna and the EUT is well calibrated. The test setup is illustrated in Figure 5-1, and its photos are shown in Figure 5-2 and Figure 5-3.

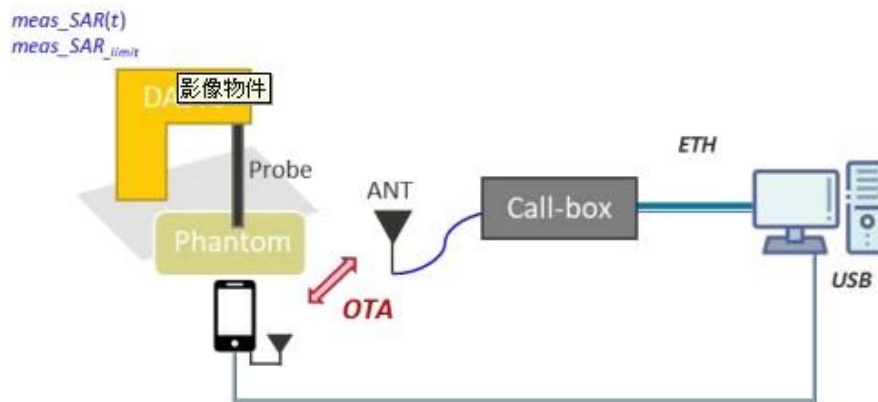


Figure 5-1 TA-SAR wireless test environment



Figure 5-2 DASY6 TA-SAR test environment with call box and PC



Figure 5-3 The other view of DASY6 TA-SAR test environment

5.2 SAR Measurement Results for Scenario 2: Time-Varying TX Power

In this scenario, Mediatek's TA-SAR algorithm is tested under more dynamic power test sequences. Test sequence #1 and test sequence #2 are include in section 4.2. All of the test cases for this scenario are relegated in Table 5-1 and the test procedure follows TA-SAR/TA-PD algorithm document. The measurement setup is shown in Figure 5-1, Figure 5-2 and Figure 5-3. The summary of the final validation results is given on table 5-1, which concludes that Mediatek's TA-SAR algorithm can maintain the time-averaged SAR always below the requirement for all test cases.

Table 5-1 Operating parameters for different TA-SAR parameters setting

Test Case	Test Scenario	Test Band	Configure	Test Position Gap (mm)	ANT	ECI	Channel	Pmax Setting	Plimit Setting	Measured Pmax	Measured Plimit	PUE max cust offset	PUE backoff offset	Unce.	Part 1 @Plimit 1-g SAR (W/kg)	Part 2 Test Result 1-g SAR (W/kg)	1g SAR Limit. (W/kg)
1	Time-varying TX power Seq 1	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	26.1	24.9	26.3	24.1	10	3	1	0.66	0.554	1.6
2	Time-varying TX power Seq 2	GSM850	GPRS 4 Tx slots	Top Edge_5mm	1	6	128	26.1	24.9	26.3	24.1	10	3	1	0.66	0.67	1.6
3	Time-varying TX power Seq 1	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	23.2	14.4	23.2	13.5	10	3	1	0.745	0.617	1.6
4	Time-varying TX power Seq 2	GSM1900	GPRS 4 Tx slots	Bottom Edge_5mm	0	6	810	23.2	14.4	23.2	13.5	10	3	1	0.745	0.601	1.6
5	Time-varying TX power Seq 1	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	23.9	14	23.9	13.5	10	3	1	0.845	0.698	1.6
6	Time-varying TX power Seq 2	WCDMA II	RMC 12.2Kbps	Bottom Edge_5mm	0	6	9262	23.9	14	23.9	13.5	10	3	1	0.845	0.678	1.6
7	Time-varying TX power Seq 1	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	23.9	21.7	24.09	21.45	10	3	1	0.573	0.495	1.6
8	Time-varying TX power Seq 2	WCDMA V	RMC 12.2Kbps	Right Cheek_0mm	1	2	4132	23.9	21.7	24.09	21.45	10	3	1	0.573	0.496	1.6
9	Time-varying TX power Seq 1	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	23.9	22.8	23.8	22.5	10	3	1	0.659	0.613	1.6
10	Time-varying TX power Seq 2	LTE Band 26	15M_QPSK_36_39	Right Cheek_0mm	1	2	26865	23.9	22.8	23.8	22.5	10	3	1	0.659	0.607	1.6
11	Time-varying TX power Seq 1	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.5	13.78	10	3	1	0.805	0.671	1.6
12	Time-varying TX power Seq 2	LTE Band 66	20M_QPSK_50_50	Bottom Edge_5mm	0	6	132572	23.9	13.9	24.5	13.78	10	3	1	0.805	0.672	1.6
13	Time-varying TX power Seq 1	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	24	22.8	24.7	22.9	10	3	1	0.637	0.561	1.6
14	Time-varying TX power Seq 2	FR1 n12	15M_BPSK_1_77	Back_5mm	0	6	141500	24	22.8	24.7	22.9	10	3	1	0.637	0.587	1.6
15	Time-varying TX power Seq 1	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1	0.786	0.639	1.6
16	Time-varying TX power Seq 2	FR1 n77	100M_BPSK_135_0	Left Edge_5mm	6	6	656000	24	13	24.7	13.3	10	3	1	0.786	0.691	1.6

- Test Case 1: GSM850 result for sequence 1

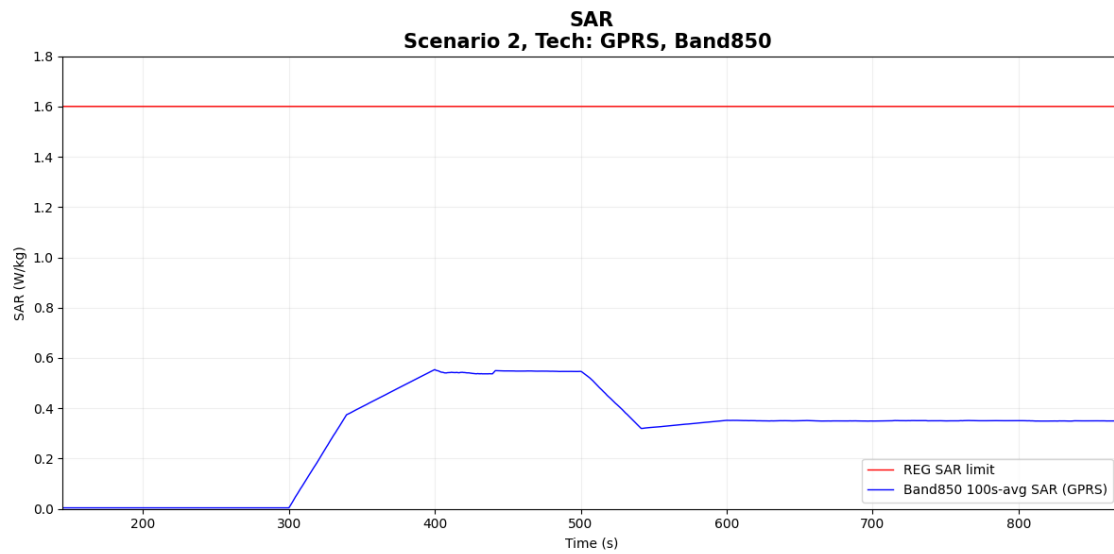


Figure of Time-averaged SAR

Validation result: **pass**

- Test Case 2: GSM850 result for sequence 2

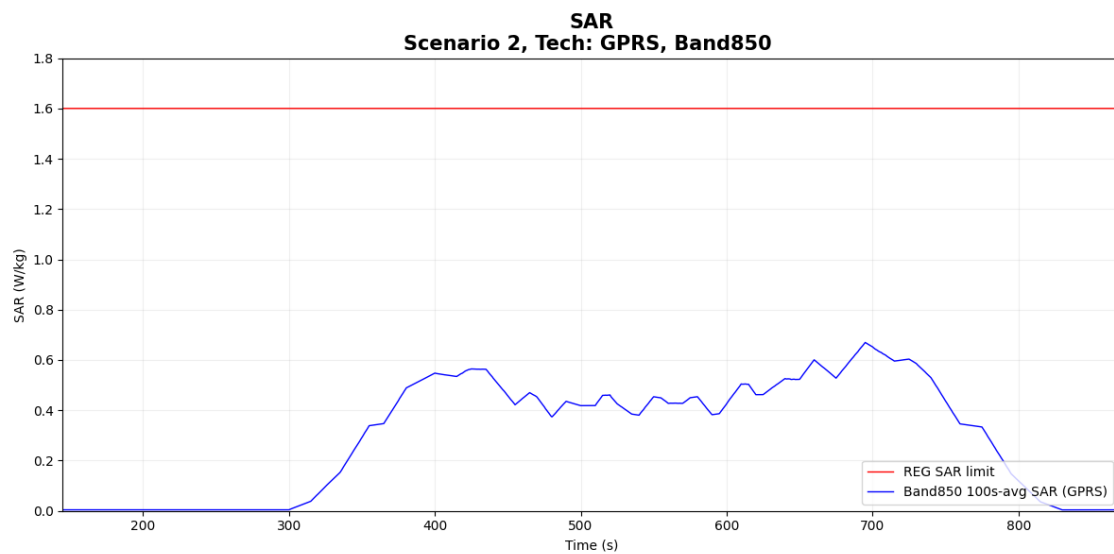
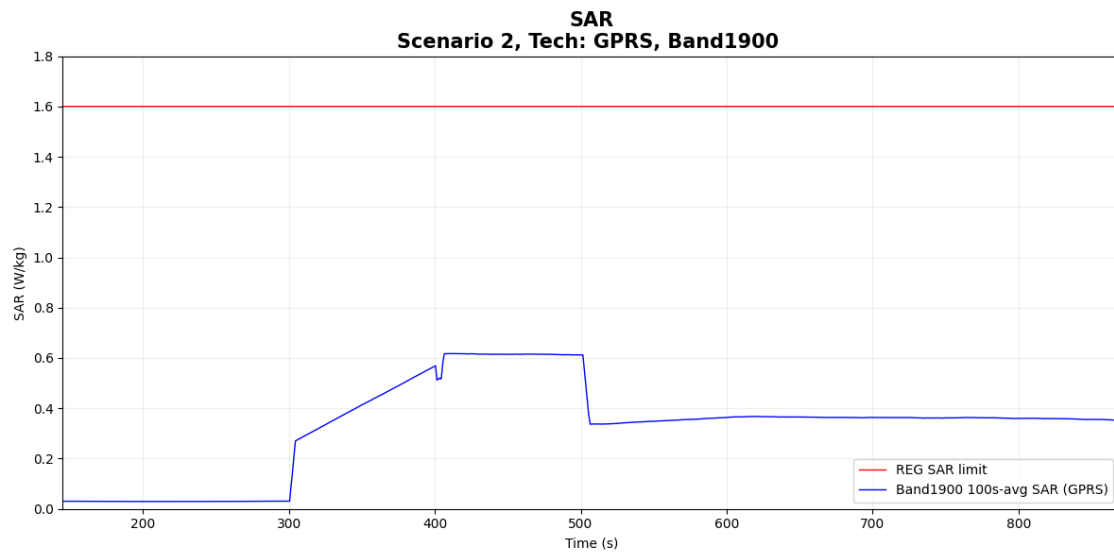


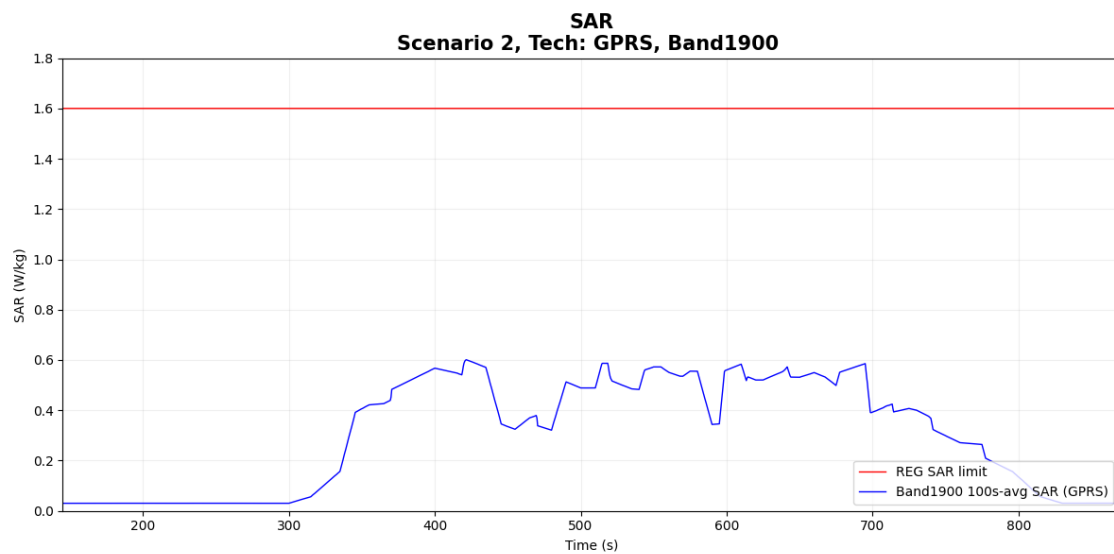
Figure of Time-averaged SAR

Validation result: **pass**

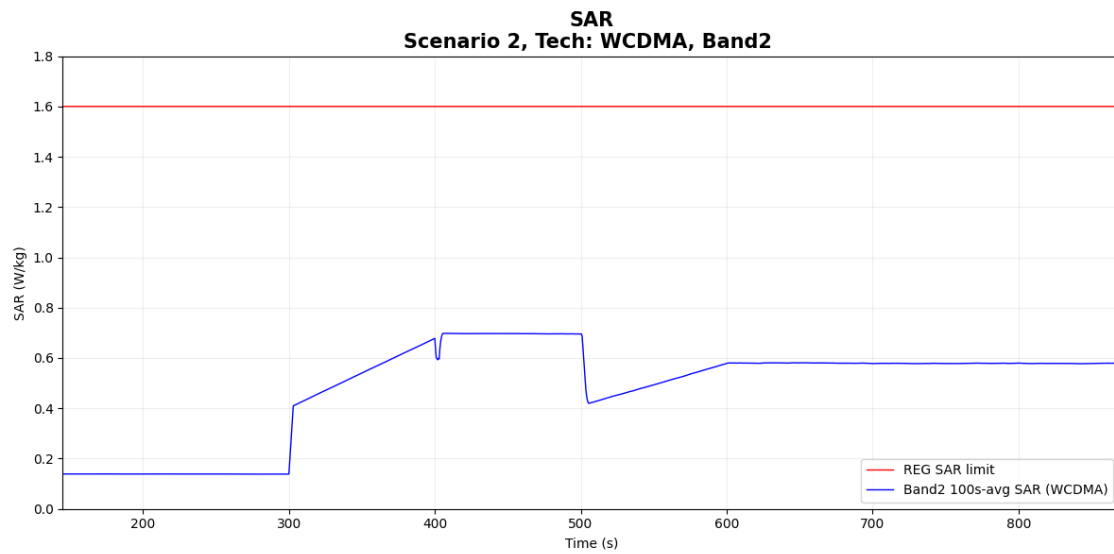
● **Test Case 3: GSM1900 result for sequence 1**



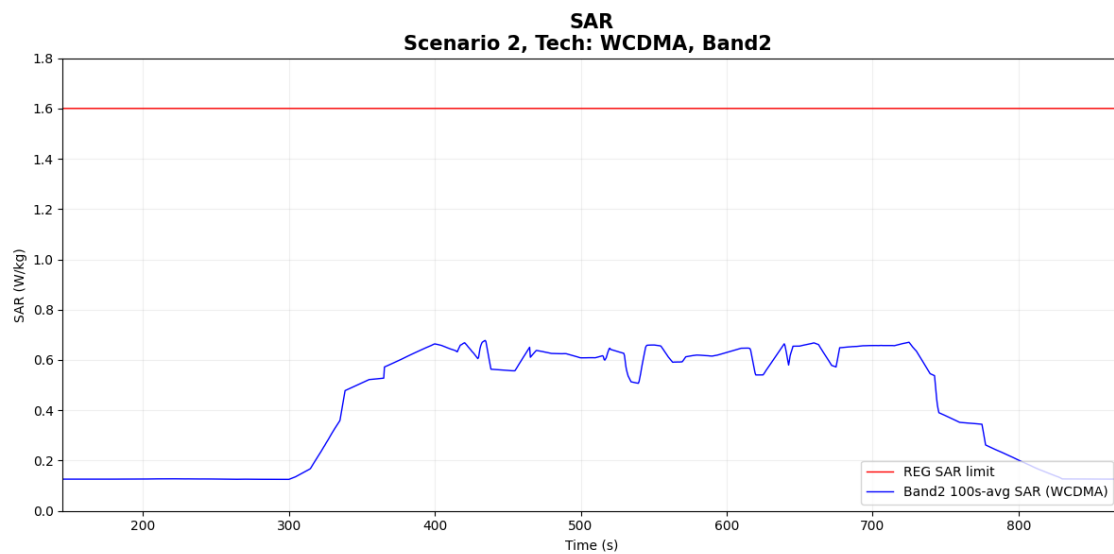
● **Test Case 4: GSM1900 result for sequence 2**



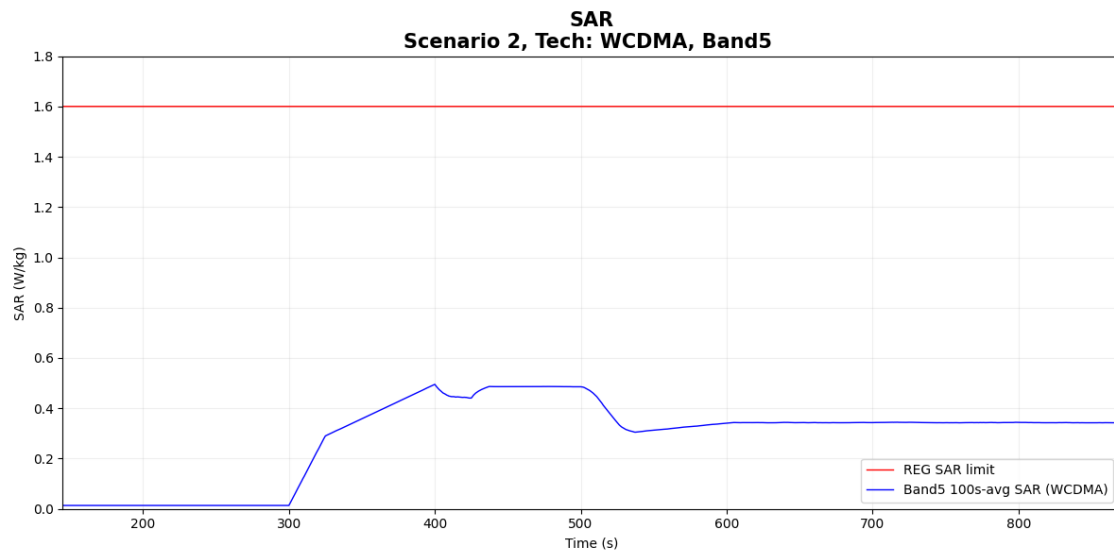
● **Test Case 5: UMTS B2 result for sequence 1**



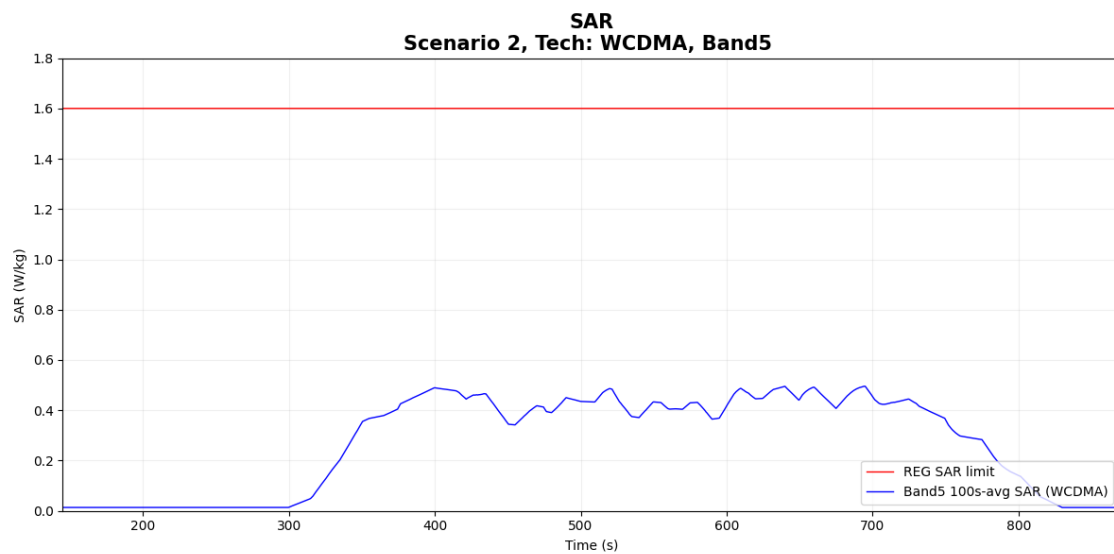
● **Test Case 6: UMTS B2 result for sequence 2**



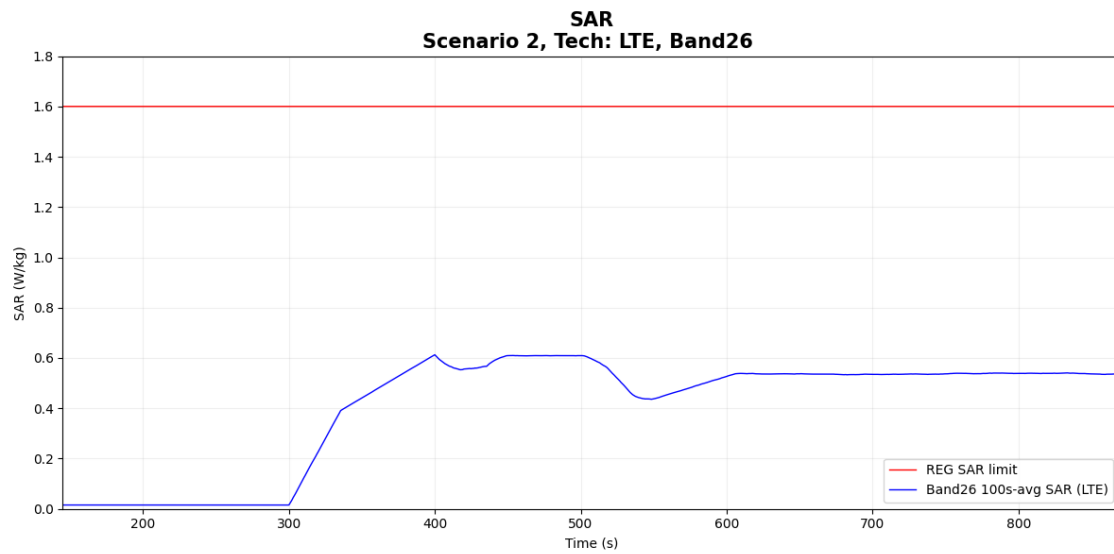
● **Test Case 7: UMTS B5 result for sequence 1**



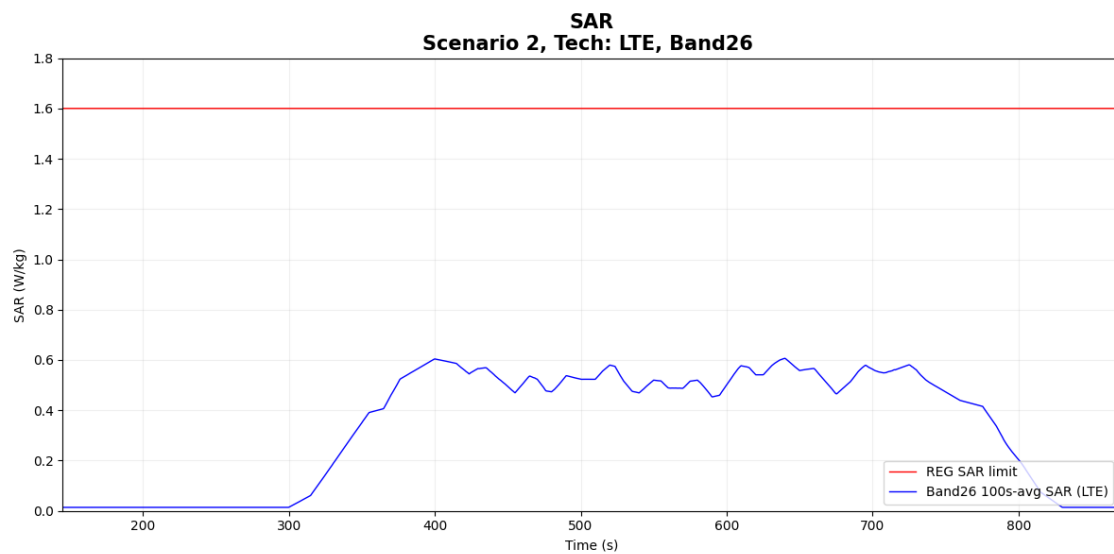
● **Test Case 8: UMTS B5 result for sequence 2**



- Test Case 9: LTE B26 result for sequence 1



- Test Case 10: LTE B26 result for sequence 2



● **Test Case 11: LTE B66 result for sequence 1**

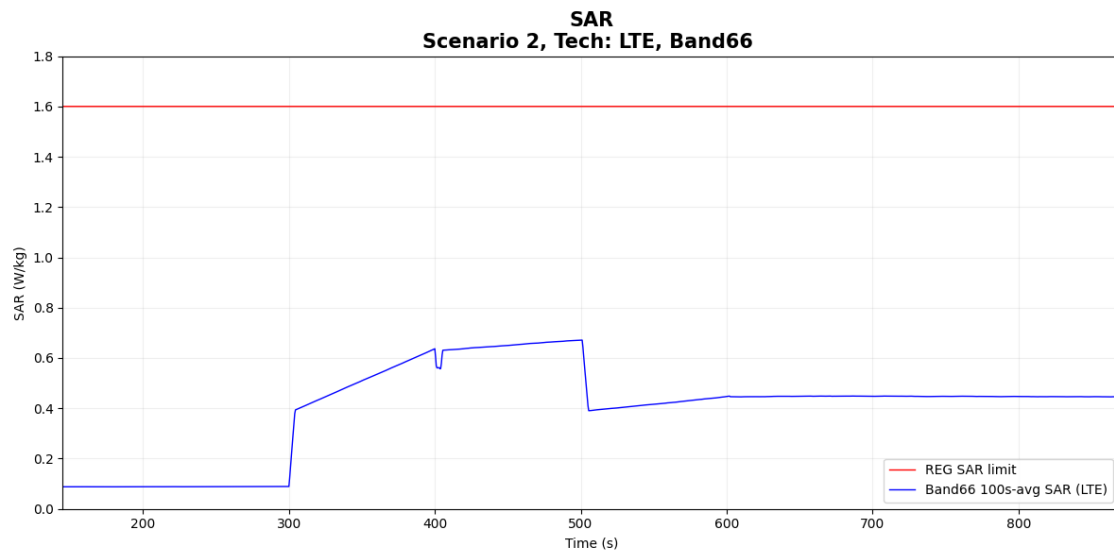


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 12: LTE B66 result for sequence 2**

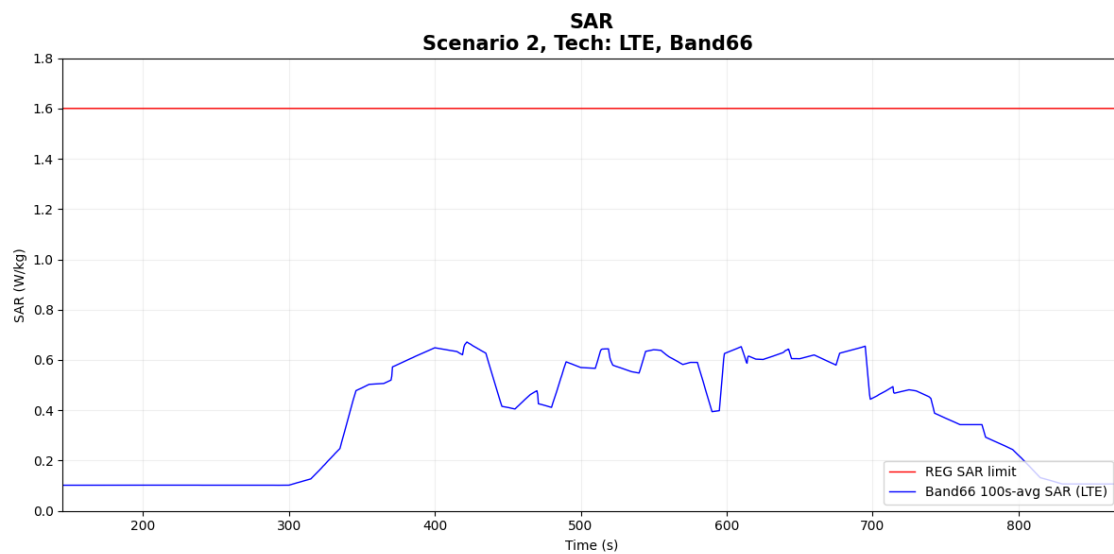


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 13: FR1 n12 result for sequence 1**

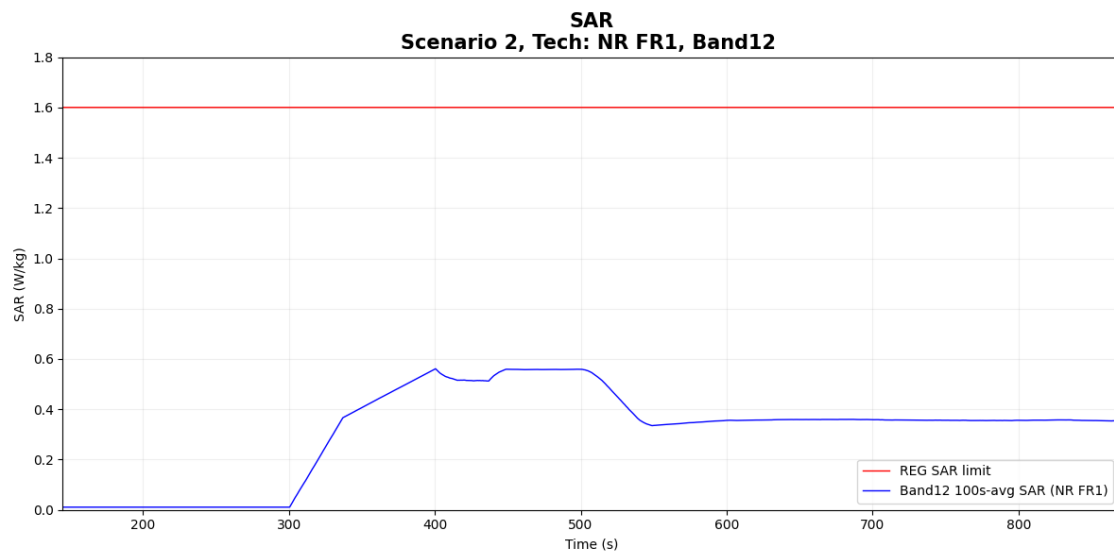


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 14: FR1 n12 result for sequence 2**

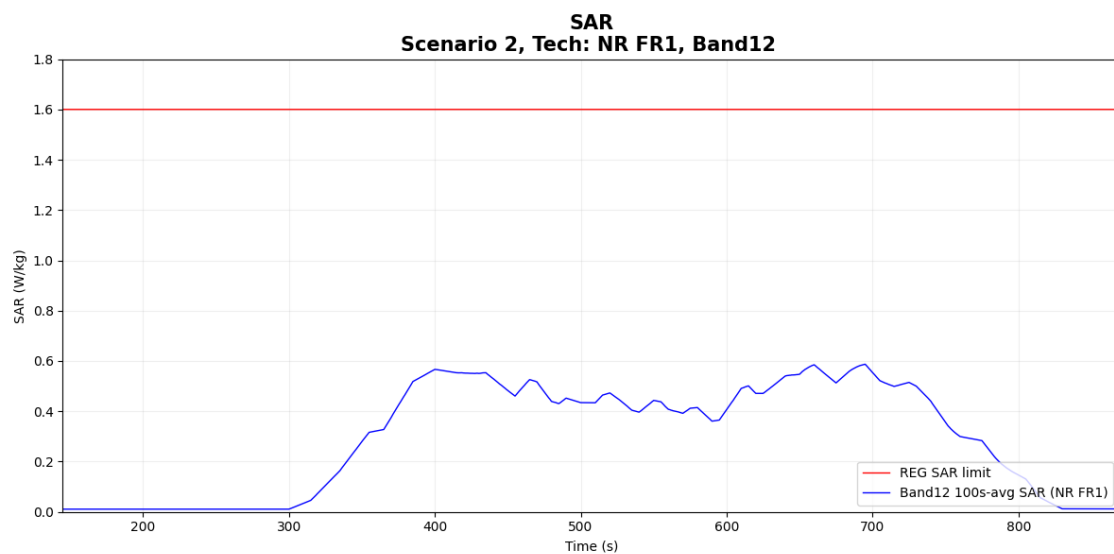


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 15: FR1 n77 result for sequence 1**

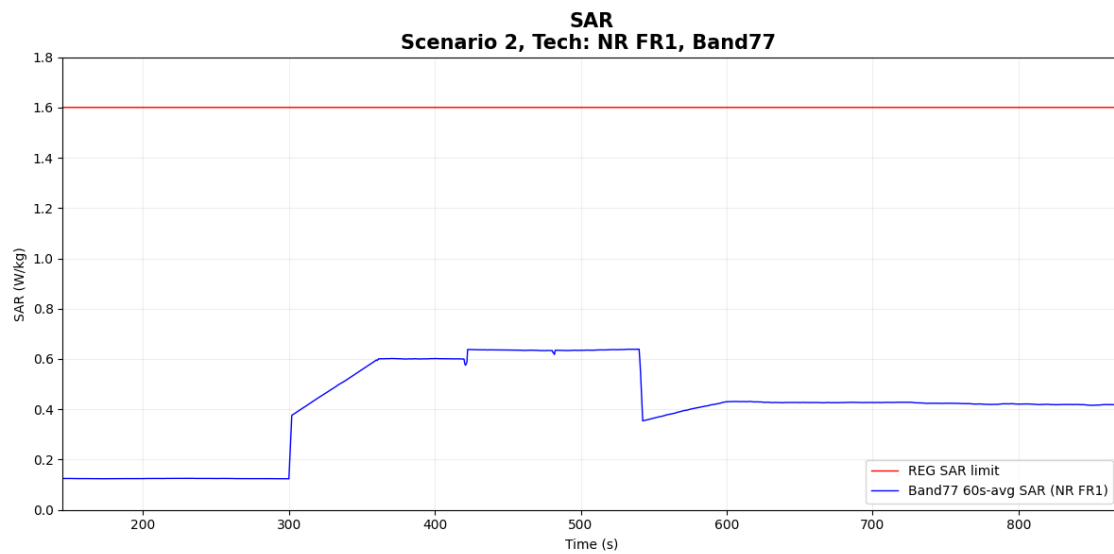


Figure of Time-averaged SAR

Validation result: pass

● **Test Case 16: FR1 n77 result for sequence 2**

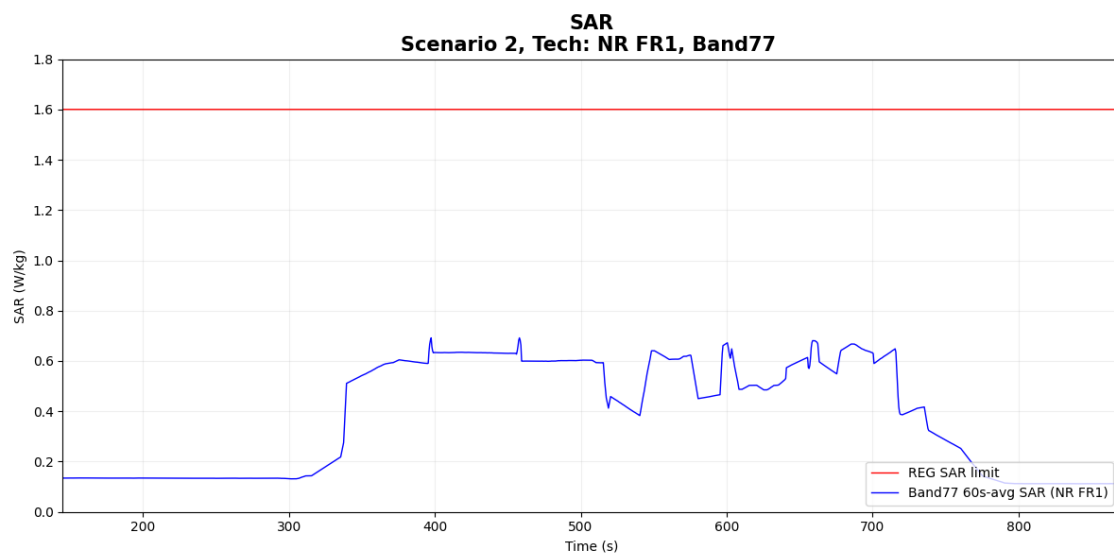


Figure of Time-averaged SAR

Validation result: pass

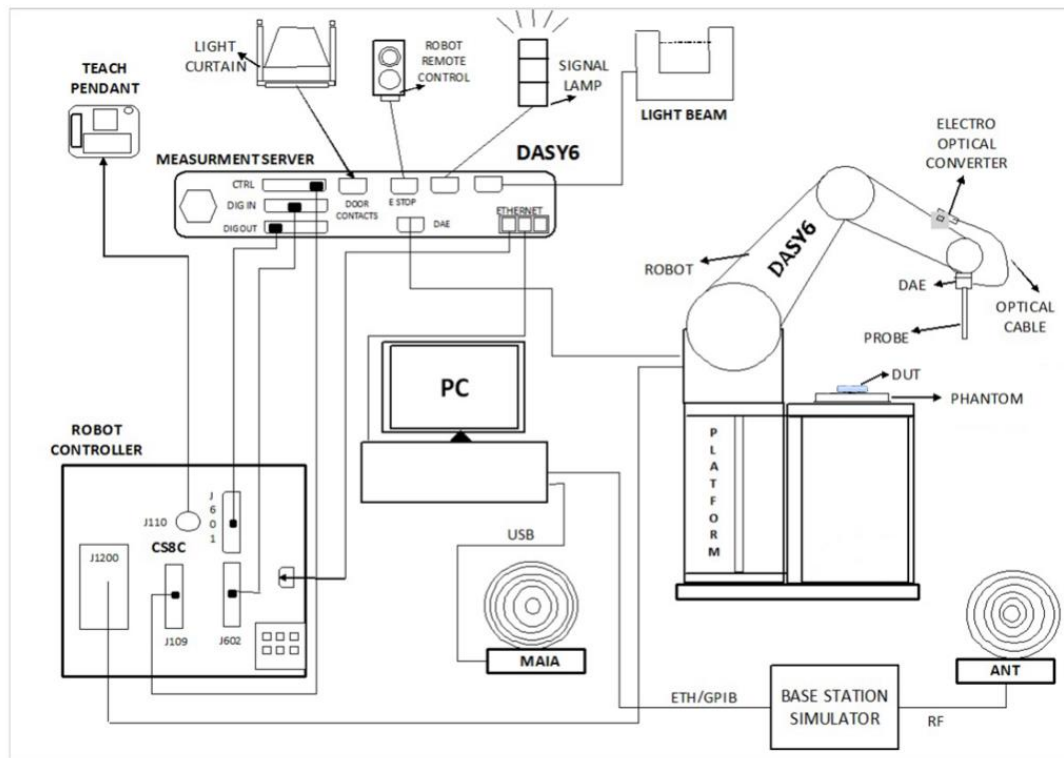
6. Conclusions

This document proposes TA-SAR test scenarios and procedures, and further proves Mediatek's TA-SAR algorithms can meet the FCC SAR regulations with the proposed test scenarios and procedures. As shown in section4, Mediatek's TA-SAR algorithms are able to maintain SAR over time below the regulatory limits. Furthermore, the near-field measurements results shown in section 5 demonstrate that Mediatek's TA-SAR algorithms really can maintain SAR over time below the regulatory limits under the proposed test procedures. Based on the provided measurement evidences, it is concluded that Mediatek's TA-SAR algorithms can be tested by using the proposed test methodology for compliance.

7. cDASY6 System Verification

7.1 The system to be used for the near field power density measurement

- SPEAG DASY6 system
- SPEAG cDASY6 5G module software



7.2 Test Site Location

Sporton Lab and below test site location are accredited to ISO 17025 by Taiwan Accreditation Foundation (TAF code: 3786). The ISED Assigned Code is 4086H

Test Site	SPORTON INTERNATIONAL INC. Wensan Laboratory	
Test Site Location	4086H No.58, Aly. 75, Ln. 564, Wenhua 3rd, Rd., Guishan Dist., Taoyuan City 333010, Taiwan	
Test Site No.	SAR-5G NR01-HY	SAR-5G NR02-HY

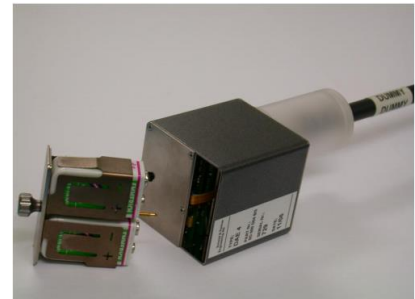
7.3 SAR E-Field Probe

Construction	Symmetric design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)	
Frequency	10 MHz – >6 GHz Linearity: ± 0.2 dB (30 MHz – 6 GHz)	
Directivity	± 0.3 dB in TSL (rotation around probe axis) ± 0.5 dB in TSL (rotation normal to probe axis)	
Dynamic Range	10 μ W/g – >100 mW/g Linearity: ± 0.2 dB (noise: typically <1 μ W/g)	
Dimensions	Overall length: 337 mm (tip: 20 mm) Tip diameter: 2.5 mm (body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	

7.4 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200 MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80 dB.



8. Test Equipment List

Manufacturer	Name of Equipment	Type/Model	Serial Number	Calibration	
				Last Cal.	Due Date
SPEAG	750MHz System Validation Kit	D750V3	1107	Jun. 11, 2025	Jun. 10, 2026
SPEAG	835MHz System Validation Kit	D835V2	4d167	Dec. 02, 2025	Dec. 01, 2026
SPEAG	1750MHz System Validation Kit ⁽²⁾	D1750V2	1112	Feb. 20, 2025	Feb. 18, 2027
SPEAG	1900MHz System Validation Kit	D1900V2	5d185	Jun. 11, 2025	Jun. 10, 2026
SPEAG	3900MHz System Validation Kit ⁽²⁾	D3900V2	1092	May. 15, 2023	May. 12, 2026
SPEAG	Data Acquisition Electronics	DAE4	1707	Nov. 20, 2025	Nov. 19, 2026
SPEAG	Data Acquisition Electronics	DAE4ip	1800	Jun. 16, 2025	Jun. 15, 2026
SPEAG	Dosimetric E-Field Probe	EX3DV4	7625	Dec. 09, 2025	Dec. 08, 2026
SPEAG	Dosimetric E-Field Probe	EX3DV4	7785	Nov. 26, 2025	Nov. 25, 2026
Testo	Hygro meter	608-H1	45196600	Nov. 04, 2025	Nov. 03, 2026
Anritsu	Radio Communication Analyzer	MT8821C	6201341950	Nov. 20, 2025	Nov. 19, 2026
Keysight	5G Wireless Test Platform	E7515B	MY58300712	Sep. 09, 2025	Sep. 08, 2026
R&S	Wideband Radio Communication Tester	CMW500	115793	Nov. 26, 2025	Nov. 25, 2026
SPEAG	Device Holder	N/A	N/A	N/A	N/A
Anritsu	Signal Generator	MG3710A	6201502524	Sep. 24, 2025	Sep. 23, 2026
Keysight	ENA Network Analyzer	E5071C	MY46104758	Oct. 14, 2025	Oct. 13, 2026
SPEAG	Dielectric Probe Kit	DAK-3.5	1126	Sep. 16, 2025	Sep. 15, 2026
LINE SEIKI	Digital Thermometer	DTM3000-spezial	3690	Aug. 14, 2025	Aug. 13, 2026
R&S	Power Sensor	NRP8S	109688	Sep. 15, 2025	Sep. 14, 2026
R&S	Power Sensor	NRP8S	103999	Jan. 06, 2025	Jan. 05, 2027
Anritsu	Power Meter	ML2496A	2119003	Jul. 14, 2025	Jul. 13, 2026
Anritsu	Power Sensor	MA2411B	1726150	Aug. 18, 2025	Aug. 17, 2026
Anritsu	Spectrum Analyzer	MS2830A	6201396378	Jul. 09, 2025	Jul. 08, 2026
Mini-Circuits	Power Amplifier	ZVE-3W-83+	1651	Dec. 24, 2025	Dec. 23, 2026
Bojay	mmwave measurement horn antenna	AQRH-15	23	Note 1	
Warison	10-50 GHz Directional Coupler	WCOU-10-50S-10	WR889BMC481	Note 1	
ATM	500M-18GHz Dual Directional Coupler	C122H-10	P610410z-02	Note 1	
Woken	Attenuator 1	WK0602-XX	N/A	Note 1	
Woken	Attenuator 2	PE7005-10	N/A	Note 1	
Woken	Attenuator 3	PE7005- 3	N/A	Note 1	

General Note:

1. Prior to system verification and validation, the path loss from the signal generator to the system check source and the power meter, which includes the amplifier, cable, attenuator and directional coupler, was measured by the network analyzer. The reading of the power meter was offset by the path loss difference between the path to the power meter and the path to the system check source to monitor the actual power level fed to the system check source.
2. The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval. The justification data in appendix C can be found which the return loss is < -20dB, within 20% of prior calibration, the impedance is within 5 ohm of prior calibration for each dipole.

9. System verification and validation

9.1 Tissue Verification

The tissue dielectric parameters of tissue-equivalent media used for SAR measurements must be characterized within a temperature range of 18°C to 25°C, measured with calibrated instruments and apparatuses, such as network analyzers and temperature probes. The temperature of the tissue-equivalent medium during SAR measurement must also be within 18°C to 25°C and within $\pm 2^\circ\text{C}$ of the temperature when the tissue parameters are characterized. The tissue dielectric measurement system must be calibrated before use. The dielectric parameters must be measured before the tissue-equivalent medium is used in a series of SAR measurements.

The liquid tissue depth was at least 15cm in the phantom for all SAR testing

The SPEAG Dasy Measurement system implement a SAR error compensation algorithm as documented in IEEE Std 1528-2013 to automatically compensate the measured SAR results for deviations between the measured and required tissue dielectric parameters, according to IEC/IEEE 62209-1528, the tolerance for "Delta (σ)" and "Delta (ϵ_r)" can be relaxed to $\pm 10\%$

<Tissue Check Results>

Frequency (MHz)	Liquid Temp. (°C)	Conductivity (σ)	Permittivity (ϵ_r)	Conductivity Target (σ)	Permittivity Target (ϵ_r)	Delta (σ) (%)	Delta (ϵ_r) (%)	Limit (%)	Date
750	22.6	0.883	42.300	0.89	41.90	-0.79	0.95	± 10	2026/3/16
835	22.2	0.912	42.000	0.90	41.50	1.33	1.20	± 10	2026/3/14
1750	22.5	1.37	40.6	1.37	40.10	0.00	1.25	± 10	2026/3/30
1900	22.2	1.42	40	1.40	40.00	1.43	0.00	± 10	2026/3/14
3900	22.7	3.040	38.700	3.33	37.51	-8.71	3.17	± 10	2026/3/31

9.2 System Verification

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10 %. Below table shows the target SAR and measured SAR after normalized to 1W input power. The table below indicates the system performance check can meet the variation criterion and the plots can be referred to Appendix D.

<System Verification Results>

Date	Frequency (MHz)	Input Power (mW)	Dipole S/N	Probe S/N	DAE S/N	Measured 1g SAR (W/kg)	Targeted 1g SAR (W/kg)	Normalized 1g SAR (W/kg)	Deviation (%)
2026/3/16	750	250	D750V3-1107	EX3DV4 - SN7785	DAE4 Sn1707	2.270	8.840	9.08	2.71
2026/3/14	835	250	D835V2-4d167	EX3DV4 - SN7785	DAE4 Sn1707	2.370	9.360	9.48	1.28
2026/3/30	1750	50	D1750V2-1112	EX3DV4 - SN7785	DAE4 Sn1707	1.770	36.300	35.4	-2.48
2026/3/14	1900	50	D1900V2-5d185	EX3DV4 - SN7785	DAE4 Sn1707	2.010	39.600	40.2	1.52
2026/3/31	3900	50	D3900V2-1092-3900	EX3DV4 - SN7625	DAE4ip Sn1800	3.030	67.000	60.6	-9.55

10. Uncertainty Assessment

Declaration of Conformity:

The test results with all measurement uncertainty excluded is presented in accordance with the regulation limits or requirements declared by manufacturers.

Comments and Explanations:

The declared of product specification for EUT presented in the report are provided by the manufacturer, and the ufacturer takes all the responsibilities for the accuracy of product specification.

The component of uncertainly may generally be categorized according to the methods used to evaluate them. The evaluation of uncertainly by the statistical analysis of a series of observations is termed a Type An evaluation of uncertainty. The evaluation of uncertainty by means other than the statistical analysis of a series of observation is termed a Type B evaluation of uncertainty. Each component of uncertainty, however evaluated, is represented by an estimated standard deviation, termed standard uncertainty, which is determined by the positive square root of the estimated variance.

A Type A evaluation of standard uncertainty may be based on any valid statistical method for treating data. This includes calculating the standard deviation of the mean of a series of independent observations; using the method of least squares to fit a curve to the data in order to estimate the parameter of the curve and their standard deviations; or carrying out an analysis of variance in order to identify and quantify random effects in certain kinds of measurement.

A type B evaluation of standard uncertainty is typically based on scientific judgment using all of the relevant information available. These may include previous measurement data, experience, and knowledge of the behavior and properties of relevant materials and instruments, manufacture's specification, data provided in calibration reports and uncertainties assigned to reference data taken from handbooks. Broadly speaking, the uncertainty is either obtained from an outdoor source or obtained from an assumed distribution, such as the normal distribution, rectangular or triangular distributions indicated in table below.

Uncertainty Distributions	Normal	Rectangular	Triangular	U-Shape
Multi-plying Factor ^(a)	1/k ^(b)	1/√3	1/√6	1/√2

(a) standard uncertainty is determined as the product of the multiplying factor and the estimated range of variations in the measured quantity

(b) κ is the coverage factor

Standard Uncertainty for Assumed Distribution

The combined standard uncertainty of the measurement result represents the estimated standard deviation of the result. It is obtained by combining the individual standard uncertainties of both Type A and Type B evaluation using the usual "root-sum-squares" (RSS) methods of combining standard deviations by taking the positive square root of the estimated variances.

Expanded uncertainty is a measure of uncertainty that defines an interval about the measurement result within which the measured value is confidently believed to lie. It is obtained by multiplying the combined standard uncertainty by a coverage factor. Typically, the coverage factor ranges from 2 to 3. Using a coverage factor allows the true value of a measured quantity to be specified with a defined probability within the specified uncertainty range. For purpose of this document, a coverage factor two is used, which corresponds to confidence interval of about 95 %. The DASY uncertainty Budget is shown in the following tables.

The judgment of conformity in the report is based on the measurement results excluding the measurement uncertainty.

Applicable for SAR Measurements:

Uncertainty Budget (4 MHz - 10 GHz range)							
Error Description	Uncertainty Value (±%)	Probability	Divisor	(Ci) 1g	(Ci) 10g	Standard Uncertainty (1g) (±%)	Standard Uncertainty (10g) (±%)
Measurement System							
Probe Calibration	18.60	N	2	1	1	9.3	9.3
Axial Isotropy	4.70	R	1.732	0.7	0.7	1.9	1.9
Hemispherical Isotropy	9.60	R	1.732	0.7	0.7	3.9	3.9
Linearity	4.70	R	1.732	1	1	2.7	2.7
Modulation Response	4.68	R	1.732	1	1	2.7	2.7
System Detection Limits	1.00	R	1.732	1	1	0.6	0.6
Boundary Effects	2.00	R	1.732	1	1	1.2	1.2
Readout Electronics	0.30	N	1	1	1	0.3	0.3
Response Time	0.00	R	1.732	1	1	0.0	0.0
Integration Time	2.60	R	1.732	1	1	1.5	1.5
RF Ambient Noise	3.00	R	1.732	1	1	1.7	1.7
RF Ambient Reflections	3.00	R	1.732	1	1	1.7	1.7
Probe Positioner	0.40	R	1.732	1	1	0.2	0.2
Probe Positioning	6.70	R	1.732	1	1	3.9	3.9
Post-processing	4.00	R	1.732	1	1	2.3	2.3
Test Sample Related							
Device Holder	3.60	N	1	1	1	3.6	3.6
Test sample Positioning	3.03	N	1	1	1	3.0	3.0
Power Scaling	0.00	R	1.732	1	1	0.0	0.0
Power Drift	5.00	R	1.732	1	1	2.9	2.9
Phantom and Setup							
Phantom Uncertainty	7.60	R	1.732	1	1	4.4	4.4
SAR correction	0.00	R	1.732	1	0.84	0.0	0.0
Liquid Conductivity Repeatability	0.03	N	1	0.78	0.77	0.0	0.0
Liquid Conductivity (target)	5.00	R	1.732	0.78	0.77	2.3	2.2
Liquid Conductivity (mea.)	2.50	R	1.732	0.78	0.77	1.1	1.1
Temp. unc. - Conductivity	3.68	R	1.732	0.78	0.77	1.7	1.6
Liquid Permittivity Repeatability	0.02	N	1	0.23	0.26	0.0	0.0
Liquid Permittivity (target)	5.00	R	1.732	0.23	0.26	0.7	0.8
Liquid Permittivity (mea.)	2.50	R	1.732	0.23	0.26	0.3	0.4
Temp. unc. - Permittivity	0.84	R	1.732	0.23	0.26	0.1	0.1
Combined Std. Uncertainty						14.5%	14.2%
Coverage Factor for 95 %						K=2	K=2
Expanded STD Uncertainty						29.0%	28.4%